

## MCF52235 ColdFire Microcontroller Data Sheet

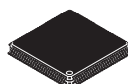
Supports MCF52230, MCF52231,  
MCF52232, MCF52233, MCF52234,  
MCF52235, and MCF52236

The MCF52235 is a member of the ColdFire® family of reduced instruction set computing (RISC) microcontrollers. This document provides an overview of the MCF52235 microcontroller family, focusing on its highly integrated and diverse feature set.

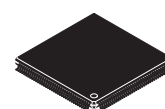
This 32-bit device is based on the Version 2 ColdFire core operating at a frequency up to 60 MHz, offering high performance and low power consumption. On-chip memories connected tightly to the processor core include up to 256 Kbytes of Flash and 32 Kbytes of static random access memory (SRAM). On-chip modules include:

- V2 ColdFire core providing 56 Dhrystone 2.1 MIPS @ 60 MHz executing out of on-chip Flash memory using enhanced multiply accumulate (EMAC) and hardware divider
- Enhanced Multiply Accumulate Unit (EMAC) and hardware divide module
- Cryptographic Acceleration Unit (CAU) coprocessor
- Fast Ethernet Controller (FEC)
- On-chip Ethernet Transceiver (EPHY)
- FlexCAN controller area network (CAN) module
- Three universal asynchronous/synchronous receiver/transmitters (UARTs)
- Inter-integrated circuit (I<sup>2</sup>C™) bus controller
- Queued serial peripheral interface (QSPI) module
- Eight-channel 10- or 12-bit fast analog-to-digital converter (ADC)
- Four channel direct memory access (DMA) controller
- Four 32-bit input capture/output compare timers with DMA support (DTIM)
- Four-channel general-purpose timer (GPT) capable of input capture/output compare, pulse width modulation (PWM) and pulse accumulation
- Eight/Four-channel 8/16-bit pulse width modulation timers (two adjacent 8-bit PWMs can be concatenated to form a single 16-bit timer)

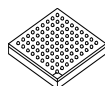
## MCF52235



LQFP-80  
14mm x 14mm



LQFP-112  
20mm\_x\_20mm



MAPBGA-121  
12mm\_x\_12mm

- Two 16-bit periodic interrupt timers (PITs)
- Real-time clock (RTC) module
- Programmable software watchdog timer
- Two interrupt controllers providing every peripheral with a unique selectable-priority interrupt vector plus seven external interrupts with fixed levels/priorities
- Clock module with support for crystal or external oscillator and integrated phase-locked loop (PLL)
- Test access/debug port (JTAG, BDM)

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# 1 MCF52235 Family Configurations

Table 1. MCF52235 Family Configurations

| Module                                                                | 52230               | 52231               | 52232         | 52233               | 52234                     | 52235                     | 52236         |
|-----------------------------------------------------------------------|---------------------|---------------------|---------------|---------------------|---------------------------|---------------------------|---------------|
| Version 2 ColdFire Core with EMAC (Enhanced Multiply-Accumulate Unit) | •                   | •                   | •             | •                   | •                         | •                         | •             |
| System Clock (MHz)                                                    | 60                  | 60                  | 50            | 60                  | 60                        | 60                        | 50            |
| Performance (Dhrystone 2.1 MIPS)                                      | 56                  | 56                  | 46            | 56                  | 56                        | 56                        | 46            |
| Flash / Static RAM (SRAM)                                             | 128/32 Kbytes       | 128/32 Kbytes       | 128/32 Kbytes | 256/32 Kbytes       | 256/32 Kbytes             | 256/32 Kbytes             | 256/32 Kbytes |
| Interrupt Controllers (INTC0/INTC1)                                   | •                   | •                   | •             | •                   | •                         | •                         | •             |
| Fast Analog-to-Digital Converter (ADC)                                | •                   | •                   | •             | •                   | •                         | •                         | •             |
| Random Number Generator and Crypto Acceleration Unit (CAU)            | —                   | —                   | —             | —                   | —                         | •                         | —             |
| FlexCAN 2.0B Module                                                   | —                   | •                   | —             | —                   | •                         | •                         | —             |
| Fast Ethernet Controller (FEC) with on-chip interface (EPHY)          | •                   | •                   | •             | •                   | •                         | •                         | •             |
| Four-channel Direct-Memory Access (DMA)                               | •                   | •                   | •             | •                   | •                         | •                         | •             |
| Software Watchdog Timer (WDT)                                         | •                   | •                   | •             | •                   | •                         | •                         | •             |
| Programmable Interrupt Timer                                          | 2                   | 2                   | 2             | 2                   | 2                         | 2                         | 2             |
| Four-Channel General Purpose Timer                                    | •                   | •                   | •             | •                   | •                         | •                         | •             |
| 32-bit DMA Timers                                                     | 4                   | 4                   | 4             | 4                   | 4                         | 4                         | 4             |
| QSPI                                                                  | •                   | •                   | •             | •                   | •                         | •                         | •             |
| UART(s)                                                               | 3                   | 3                   | 3             | 3                   | 3                         | 3                         | 3             |
| I <sup>2</sup> C                                                      | •                   | •                   | •             | •                   | •                         | •                         | •             |
| Eight/Four-channel 8/16-bit PWM Timer                                 | •                   | •                   | •             | •                   | •                         | •                         | •             |
| General Purpose I/O Module (GPIO)                                     | •                   | •                   | •             | •                   | •                         | •                         | •             |
| Chip Configuration and Reset Controller Module                        | •                   | •                   | •             | •                   | •                         | •                         | •             |
| Background Debug Mode (BDM)                                           | •                   | •                   | •             | •                   | •                         | •                         | •             |
| JTAG - IEEE 1149.1 Test Access Port <sup>1</sup>                      | •                   | •                   | •             | •                   | •                         | •                         | •             |
| Package                                                               | 80 LQFP<br>112 LQFP | 80 LQFP<br>112 LQFP | 80 LQFP       | 80 LQFP<br>112 LQFP | 112 LQFP<br>121<br>MAPBGA | 112 LQFP<br>121<br>MAPBGA | 80 LQFP       |

<sup>1</sup> The full debug/trace interface is available only on the 112- and 121-pin packages. A reduced debug interface is bonded on the 80-pin package.

## 1.1 Block Diagram

The MCF52235 (or its variants) comes in 80- and 112-pin low-profile quad flat pack packages (LQFP) and a 121 MAPBGA, and operates in single-chip mode only. Figure 1 shows a top-level block diagram of the MCF52235.

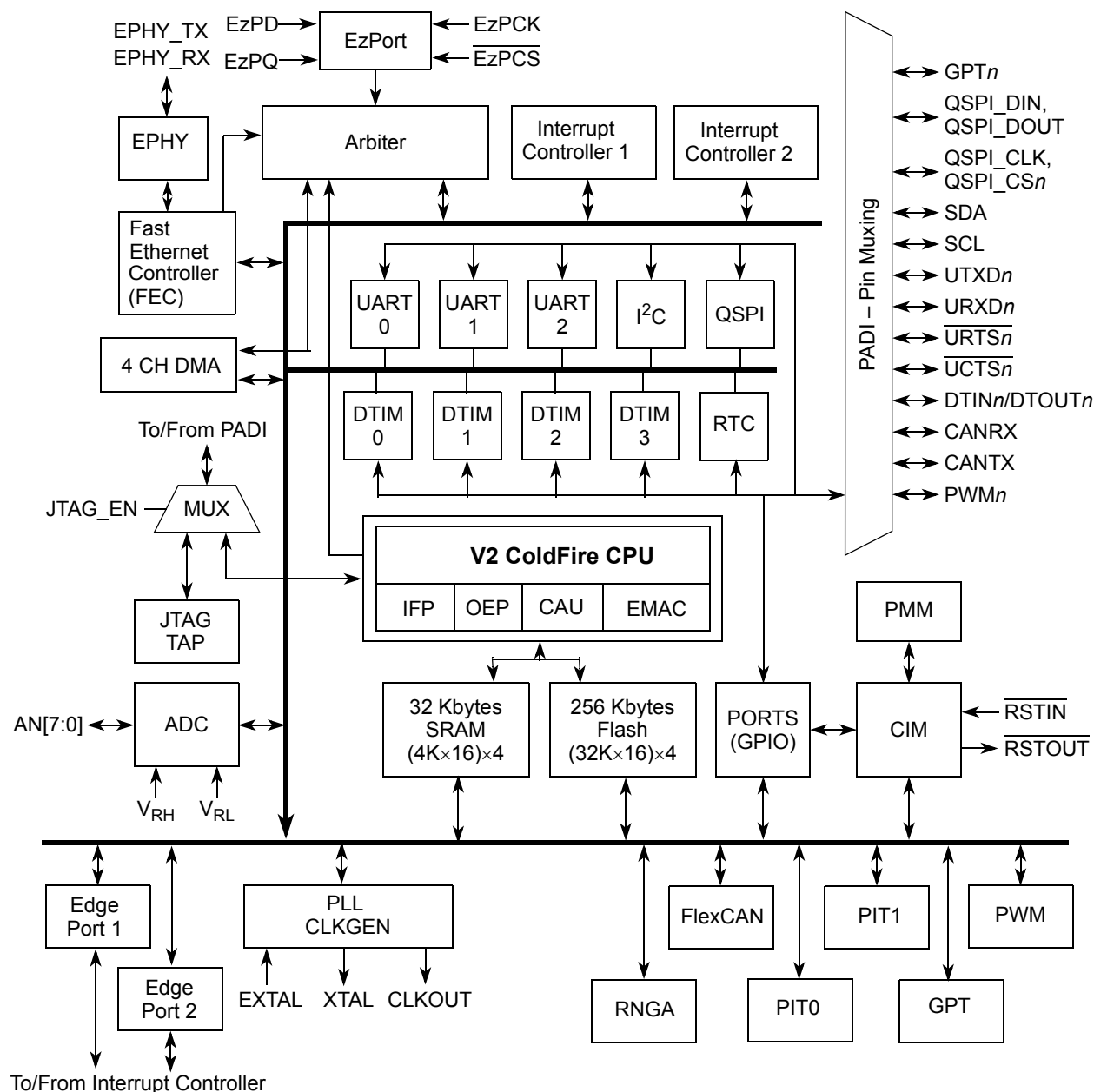


Figure 1. MCF52235 Block Diagram

## 1.2 Features

This document contains information on a new product under development. Freescale reserves the right to change or discontinue this product without notice. Specifications and information herein are subject to change without notice.

## 1.2.1 Feature Overview

The MCF52235 family includes the following features:

- Version 2 ColdFire variable-length RISC processor core
  - Static operation
  - 32-bit address and data paths on-chip
  - Up to 60 MHz processor core frequency
  - Sixteen general-purpose, 32-bit data and address registers
  - Implements ColdFire ISA\_A with extensions to support the user stack pointer register and four new instructions for improved bit processing (ISA\_A+)
  - Enhanced Multiply-Accumulate (EMAC) unit with 32-bit accumulator to support  $16 \times 16 \rightarrow 32$  or  $32 \times 32 \rightarrow 32$  operations
  - Cryptography Acceleration Unit (CAU)
    - Tightly-coupled coprocessor to accelerate software-based encryption and message digest functions
    - FIPS-140 compliant random number generator
  - Support for DES, 3DES, AES, MD5, and SHA-1 algorithms
  - Illegal instruction decode that allows for 68K emulation support
- System debug support
  - Real time trace for determining dynamic execution path
  - Background debug mode (BDM) for in-circuit debugging (DEBUG\_B+)
  - Real time debug support, with six hardware breakpoints (4 PC, 1 address and 1 data) that can be configured into a 1- or 2-level trigger
- On-chip memories
  - Up to 32 Kbytes of dual-ported SRAM on CPU internal bus, supporting core and DMA access with standby power supply support
  - Up to 256 Kbytes of interleaved Flash memory supporting 2-1-1-1 accesses
- Power management
  - Fully static operation with processor sleep and whole chip stop modes
  - Rapid response to interrupts from the low-power sleep mode (wake-up feature)
  - Clock enable/disable for each peripheral when not used
- Fast Ethernet Controller (FEC)
  - 10/100 BaseT/TX capability, half duplex or full duplex
  - On-chip transmit and receive FIFOs
  - Built-in dedicated DMA controller
  - Memory-based flexible descriptor rings
- On-chip Ethernet Transceiver (EPHY)
  - Digital adaptive equalization
  - Supports auto-negotiation
  - Baseline wander correction
  - Full-/Half-duplex support in all modes
  - Loopback modes
  - Supports MDIO preamble suppression
  - Jumbo packet
- FlexCAN 2.0B module

- Based on and includes all existing features of the Freescale TouCAN module
- Full implementation of the CAN protocol specification version 2.0B
  - Standard Data and Remote Frames (up to 109 bits long)
  - Extended Data and Remote Frames (up to 127 bits long)
  - 0–8 bytes data length
  - Programmable bit rate up to 1 Mbit/sec
- Flexible Message Buffers (MBs), totalling up to 16 message buffers of 0–8 byte data length each, configurable as Rx or Tx, all supporting standard and extended messages
- Unused Message Buffer space can be used as general purpose RAM space
- Listen only mode capability
- Content-related addressing
- No read/write semaphores required
- Three programmable mask registers: global for MBs 0-13, special for MB14, and special for MB15
- Programmable transmit-first scheme: lowest ID or lowest buffer number
- Time stamp based on 16-bit free-running timer
- Global network time, synchronized by a specific message
- Maskable interrupts
- Three universal asynchronous/synchronous receiver transmitters (UARTs)
  - 16-bit divider for clock generation
  - Interrupt control logic with maskable interrupts
  - DMA support
  - Data formats can be 5, 6, 7 or 8 bits with even, odd or no parity
  - Up to 2 stop bits in 1/16 increments
  - Error-detection capabilities
  - Modem support includes request-to-send (RTS) and clear-to-send (CTS) lines for two UARTs
  - Transmit and receive FIFO buffers
- I<sup>2</sup>C module
  - Interchip bus interface for EEPROMs, LCD controllers, A/D converters, and keypads
  - Fully compatible with industry-standard I<sup>2</sup>C bus
  - Master and slave modes support multiple masters
  - Automatic interrupt generation with programmable level
- Queued serial peripheral interface (QSPI)
  - Full-duplex, three-wire synchronous transfers
  - Up to four chip selects available
  - Master mode operation only
  - Programmable bit rates up to half the CPU clock frequency
  - Up to 16 pre-programmed transfers
- Fast analog-to-digital converter (ADC)
  - Eight analog input channels
  - 12-bit resolution
  - Minimum 1.125  $\mu$ s conversion time
  - Simultaneous sampling of two channels for motor control applications
  - Single-scan or continuous operation
  - Optional interrupts on conversion complete, zero crossing (sign change), or under/over low/high limit
  - Unused analog channels can be used as digital I/O

- Four 32-bit DMA timers
  - 17-ns resolution at 60 MHz
  - Programmable sources for clock input, including an external clock option
  - Programmable prescaler
  - Input capture capability with programmable trigger edge on input pin
  - Output compare with programmable mode for the output pin
  - Free run and restart modes
  - Maskable interrupts on input capture or output compare
  - DMA trigger capability on input capture or output compare
- Four-channel general purpose timers
  - 16-bit architecture
  - Programmable prescaler
  - Output pulse widths variable from microseconds to seconds
  - Single 16-bit input pulse accumulator
  - Toggle-on-overflow feature for pulse-width modulator (PWM) generation
  - One dual-mode pulse accumulation channel
- Pulse-width modulation timer
  - Operates as eight channels with 8-bit resolution or four channels with 16-bit resolution
  - Programmable period and duty cycle
  - Programmable enable/disable for each channel
  - Software selectable polarity for each channel
  - Period and duty cycle are double buffered. Change takes effect when the end of the current period is reached (PWM counter reaches zero) or when the channel is disabled.
  - Programmable center or left aligned outputs on individual channels
  - Four clock sources (A, B, SA, and SB) provide for a wide range of frequencies
  - Emergency shutdown
- Real-Time Clock (RTC)
  - Maintains system time-of-day clock
  - Provides stopwatch and alarm interrupt functions
- Two periodic interrupt timers (PITs)
  - 16-bit counter
  - Selectable as free running or count down
- Software watchdog timer
  - 32-bit counter
  - Low power mode support
- Clock Generation Features
  - Crystal input
  - On-chip PLL
  - Provides clock for integrated EPHY
- Dual Interrupt Controllers (INTC0/INTC1)
  - Support for multiple interrupt sources organized as follows:
    - Fully-programmable interrupt sources for each peripheral
    - 7 fixed-level interrupt sources
    - Seven external interrupt signals

- Unique vector number for each interrupt source
- Ability to mask any individual interrupt source or all interrupt sources (global mask-all)
- Support for hardware and software interrupt acknowledge (IACK) cycles
- Combinatorial path to provide wake-up from low power modes
- DMA controller
  - Four fully programmable channels
  - Dual-address transfer support with 8-, 16-, and 32-bit data capability, along with support for 16-byte (4 x 32-bit) burst transfers
  - Source/destination address pointers that can increment or remain constant
  - 24-bit byte transfer counter per channel
  - Auto-alignment transfers supported for efficient block movement
  - Bursting and cycle steal support
  - Software-programmable DMA requesters for the UARTs (3) and 32-bit timers (4)
- Reset
  - Separate reset in and reset out signals
  - Seven sources of reset:
    - Power-on reset (POR)
    - External
    - Software
    - Watchdog
    - Loss of clock
    - Loss of lock
    - Low-voltage detection (LVD)
  - Status flag indication of source of last reset
- Chip integration module (CIM)
  - System configuration during reset
  - Selects one of three clock modes
  - Configures output pad drive strength
  - Unique part identification number and part revision number
- General purpose I/O interface
  - Up to 56 bits of general purpose I/O
  - Bit manipulation supported via set/clear functions
  - Programmable drive strengths
  - Unused peripheral pins may be used as extra GPIO
- JTAG support for system level board testing

## 1.2.2 V2 Core Overview

The version 2 ColdFire processor core is comprised of two separate pipelines decoupled by an instruction buffer. The two-stage instruction fetch pipeline (IFP) is responsible for instruction-address generation and instruction fetch. The instruction buffer is a first-in-first-out (FIFO) buffer that holds prefetched instructions awaiting execution in the operand execution pipeline (OEP). The OEP includes two pipeline stages. The first stage decodes instructions and selects operands (DSOC); the second stage (AGEX) performs instruction execution and calculates operand effective addresses, if needed.

The V2 core implements the ColdFire instruction set architecture revision A+ with added support for a separate user stack pointer register and four new instructions to assist in bit processing. Additionally, the MCF52235 core includes the enhanced multiply-accumulate (EMAC) unit for improved signal processing capabilities. The EMAC implements a three-stage arithmetic

pipeline, optimized for 16×16 bit operations, with support for one 32-bit accumulator. Supported operands include 16- and 32-bit signed and unsigned integers, signed fractional operands, and a complete set of instructions to process these data types. The EMAC provides support for execution of DSP operations within the context of a single processor at a minimal hardware cost.

## 1.2.3 Integrated Debug Module

The ColdFire processor core debug interface is provided to support system debugging in conjunction with low-cost debug and emulator development tools. Through a standard debug interface, access debug information and real-time tracing capability is provided on 112-and 121-lead packages. This allows the processor and system to be debugged at full speed without the need for costly in-circuit emulators.

The on-chip breakpoint resources include a total of nine programmable 32-bit registers: an address and an address mask register, a data and a data mask register, four PC registers, and one PC mask register. These registers can be accessed through the dedicated debug serial communication channel or from the processor's supervisor mode programming model. The breakpoint registers can be configured to generate triggers by combining the address, data, and PC conditions in a variety of single- or dual-level definitions. The trigger event can be programmed to generate a processor halt or initiate a debug interrupt exception. The MCF52235 implements revision B+ of the ColdFire Debug Architecture.

The MCF52235's interrupt servicing options during emulator mode allow real-time critical interrupt service routines to be serviced while processing a debug interrupt event, thereby ensuring that the system continues to operate even during debugging.

To support program trace, the V2 debug module provides processor status (PST[3:0]) and debug data (DDATA[3:0]) ports. These buses and the PSTCLK output provide execution status, captured operand data, and branch target addresses defining processor activity at the CPU's clock rate. The MCF52235 includes a new debug signal, ALLPST. This signal is the logical AND of the processor status (PST[3:0]) signals and is useful for detecting when the processor is in a halted state (PST[3:0] = 1111).

The full debug/trace interface is available only on the 112 and 121-pin packages. However, every product features the dedicated debug serial communication channel (DSI, DSO, DSCLK) and the ALLPST signal.

## 1.2.4 JTAG

The MCF52235 supports circuit board test strategies based on the Test Technology Committee of IEEE and the Joint Test Action Group (JTAG). The test logic includes a test access port (TAP) consisting of a 16-state controller, an instruction register, and three test registers (a 1-bit bypass register, a 256-bit boundary-scan register, and a 32-bit ID register). The boundary scan register links the device's pins into one shift register. Test logic, implemented using static logic design, is independent of the device system logic.

The MCF52235 implementation can do the following:

- Perform boundary-scan operations to test circuit board electrical continuity
- Sample MCF52235 system pins during operation and transparently shift out the result in the boundary scan register
- Bypass the MCF52235 for a given circuit board test by effectively reducing the boundary-scan register to a single bit
- Disable the output drive to pins during circuit-board testing
- Drive output pins to stable levels

## 1.2.5 On-Chip Memories

### 1.2.5.1 SRAM

The dual-ported SRAM module provides a general-purpose 16- or 32-Kbyte memory block that the ColdFire core can access in a single cycle. The location of the memory block can be set to any 16- or 32-Kbyte boundary within the 4-Gbyte address space. This memory is ideal for storing critical code or data structures and for use as the system stack. Because the SRAM

## MCF52235 Family Configurations

module is physically connected to the processor's high-speed local bus, it can quickly service core-initiated accesses or memory-referencing commands from the debug module.

The SRAM module is also accessible by the DMA. The dual-ported nature of the SRAM makes it ideal for implementing applications with double-buffer schemes, where the processor and a DMA device operate in alternate regions of the SRAM to maximize system performance.

### 1.2.5.2 Flash

The ColdFire flash module (CFM) is a non-volatile memory (NVM) module that connects to the processor's high-speed local bus. The CFM is constructed with four banks of 32 K×16-bit flash arrays to generate 256 Kbytes of 32-bit flash memory. These arrays serve as electrically erasable and programmable, non-volatile program and data memory. The flash memory is ideal for program and data storage for single-chip applications, allowing for field reprogramming without requiring an external high voltage source. The CFM interfaces to the ColdFire core through an optimized read-only memory controller which supports interleaved accesses from the 2-cycle flash arrays. A backdoor mapping of the flash memory is used for all program, erase, and verify operations, as well as providing a read datapath for the DMA. Flash memory may also be programmed via the EzPort, which is a serial flash programming interface that allows the flash to be read, erased and programmed by an external controller in a format compatible with most SPI bus flash memory chips. This allows easy device programming via Automated Test Equipment or bulk programming tools.

### 1.2.6 Cryptography Acceleration Unit

The MCF52235 device incorporates two hardware accelerators for cryptographic functions. First, the CAU is a coprocessor tightly-coupled to the V2 ColdFire core that implements a set of specialized operations to increase the throughput of software-based encryption and message digest functions, specifically the DES, 3DES, AES, MD5 and SHA-1 algorithms. Second, a random number generator provides FIPS-140 compliant 32-bit values to security processing routines. Both modules supply critical acceleration to software-based cryptographic algorithms at a minimal hardware cost.

### 1.2.7 Power Management

The MCF52235 incorporates several low-power modes of operation which are entered under program control and exited by several external trigger events. An integrated power-on reset (POR) circuit monitors the input supply and forces an MCU reset as the supply voltage rises. The low voltage detector (LVD) monitors the supply voltage and is configurable to force a reset or interrupt condition if it falls below the LVD trip point.

### 1.2.8 FlexCAN

The FlexCAN module is a communication controller implementing version 2.0 of the CAN protocol parts A and B. The CAN protocol can be used as an industrial control serial data bus, meeting the specific requirements of reliable operation in a harsh EMI environment with high bandwidth. This instantiation of FlexCAN has 16 message buffers.

### 1.2.9 UARTs

The MCF52235 has three full-duplex UARTs that function independently. The three UARTs can be clocked by the system bus clock, eliminating the need for an external clock source. On smaller packages, the third UART is multiplexed with other digital I/O functions.

### 1.2.10 I<sup>2</sup>C Bus

The I<sup>2</sup>C bus is a two-wire, bidirectional serial bus that provides a simple, efficient method of data exchange and minimizes the interconnection between devices. This bus is suitable for applications requiring occasional communications over a short distance between many devices on a circuit board.

### 1.2.11 QSPI

The queued serial peripheral interface (QSPI) provides a synchronous serial peripheral interface with queued transfer capability. It allows up to 16 transfers to be queued at once, minimizing the need for CPU intervention between transfers.

### 1.2.12 Fast ADC

The Fast ADC consists of an eight-channel input select multiplexer and two independent sample and hold (S/H) circuits feeding separate 10- or 12-bit ADCs. The two separate converters store their results in accessible buffers for further processing.

The ADC can be configured to perform a single scan and halt, perform a scan whenever triggered, or perform a programmed scan sequence repeatedly until manually stopped.

The ADC can be configured for sequential or simultaneous conversion. When configured for sequential conversions, up to eight channels can be sampled and stored in any order specified by the channel list register. Both ADCs may be required during a scan, depending on the inputs to be sampled.

During a simultaneous conversion, both S/H circuits are used to capture two different channels at the same time. This configuration requires that a single channel may not be sampled by both S/H circuits simultaneously.

Optional interrupts can be generated at the end of the scan sequence if a channel is out of range (measures below the low threshold limit or above the high threshold limit set in the limit registers) or at several different zero crossing conditions.

### 1.2.13 DMA Timers (DTIM0–DTIM3)

There are four independent, DMA transfer capable 32-bit timers (DTIM0, DTIM1, DTIM2, and DTIM3) on the each device. Each module incorporates a 32-bit timer with a separate register set for configuration and control. The timers can be configured to operate from the system clock or from an external clock source using one of the DTINx signals. If the system clock is selected, it can be divided by 16 or 1. The input clock is further divided by a user-programmable 8-bit prescaler which clocks the actual timer counter register (TCRn). Each of these timers can be configured for input capture or reference (output) compare mode. Timer events may optionally cause interrupt requests or DMA transfers.

### 1.2.14 General Purpose Timer (GPT)

The general purpose timer (GPT) is a 4-channel timer module consisting of a 16-bit programmable counter driven by a 7-stage programmable prescaler. Each of the four channels can be configured for input capture or output compare. Additionally, one of the channels, channel 3, can be configured as a pulse accumulator.

A timer overflow function allows software to extend the timing capability of the system beyond the 16-bit range of the counter. The input capture and output compare functions allow simultaneous input waveform measurements and output waveform generation. The input capture function can capture the time of a selected transition edge. The output compare function can generate output waveforms and timer software delays. The 16-bit pulse accumulator can operate as a simple event counter or a gated time accumulator.

## 1.2.15 Periodic Interrupt Timers (PIT0 and PIT1)

The two periodic interrupt timers (PIT0 and PIT1) are 16-bit timers that provide interrupts at regular intervals with minimal processor intervention. Each timer can count down from the value written in its PIT modulus register or can be a free-running down-counter.

## 1.2.16 Pulse Width Modulation (PWM) Timers

The MCF52235 has an 8-channel, 8-bit PWM timer. Each channel has a programmable period and duty cycle as well as a dedicated counter. Each of the modulators can create independent continuous waveforms with software-selectable duty rates from 0 to 100%. The PWM outputs have programmable polarity and can be programmed as left-aligned outputs or center-aligned outputs. For higher period and duty cycle resolution, each pair of adjacent channels ([7:6], [5:4], [3:2], and [1:0]) can be concatenated to form a single 16-bit channel. The module can, therefore, be configured to support 8/0, 6/1, 4/2, 2/3, or 0/4 8-/16-bit channels.

## 1.2.17 Software Watchdog Timer

The watchdog timer is a 32-bit timer that facilitates recovery from runaway code. The watchdog counter is a free-running down-counter that generates a reset on underflow. To prevent a reset, software must periodically restart the countdown.

## 1.2.18 Phase Locked Loop (PLL)

The clock module contains a crystal oscillator, 8 MHz on-chip relaxation oscillator (OCO), phase-locked loop (PLL), reduced frequency divider (RFD), low-power divider status/control registers, and control logic. To improve noise immunity, the PLL, crystal oscillator, and relaxation oscillator have their own power supply inputs: VDDPLL and VSSPLL. All other circuits are powered by the normal supply pins, VDD and VSS.

## 1.2.19 Interrupt Controller (INTC0/INTC1)

There are two interrupt controllers on the MCF52235. These interrupt controllers are organized as seven levels with up to nine interrupt sources per level. Each interrupt source has a unique interrupt vector, and provide each peripheral with all necessary interrupts. Each internal interrupt has a programmable level [1-7] and priority within the level. The seven external interrupts have fixed levels/priorities.

## 1.2.20 DMA Controller

The direct memory access (DMA) controller provides an efficient way to move blocks of data with minimal processor intervention. It has four channels that allow byte, word, longword, or 16-byte burst line transfers. These transfers are triggered by software explicitly setting a DCRn[START] bit or by the occurrence of certain UART or DMA timer events.

## 1.2.21 Reset

The reset controller determines the source of reset, asserts the appropriate reset signals to the system, and keeps track of what caused the last reset. There are seven sources of reset:

- External reset input
- Power-on reset (POR)
- Watchdog timer
- Phase locked-loop (PLL) loss of lock
- PLL loss of clock
- Software

- Low-voltage detector (LVD)

Control of the LVD and its associated reset and interrupt are managed by the reset controller. Other registers provide status flags indicating the last source of reset and a control bit for software assertion of the  $\overline{\text{RSTO}}$  pin.

## 1.2.22 GPIO

Nearly all pins on the MCF52235 have general purpose I/O capability in addition to their primary functions and are grouped into 8-bit ports. Some ports do not utilize all 8 bits. Each port has registers that configure, monitor, and control the port pins.

## 1.2.23 Part Numbers and Packaging

**Table 2. Orderable Part Number Summary**

| Freescal Part Number | Description                                  | Speed (MHz) | Flash/SRAM (Kbytes) | Package    | Temp range (°C) |
|----------------------|----------------------------------------------|-------------|---------------------|------------|-----------------|
| MCF52230CAF60        | MCF52230 Microcontroller                     | 60          | 128 / 32            | 80 LQFP    | -40 to +85      |
| MCF52230CAL60        | MCF52230 Microcontroller                     | 60          | 128 / 32            | 112 LQFP   | -40 to +85      |
| MCF52231CAF60        | MCF52231 Microcontroller, FlexCAN            | 60          | 128 / 32            | 80 LQFP    | -40 to +85      |
| MCF52231CAL60        | MCF52231 Microcontroller, FlexCAN            | 60          | 128 / 32            | 112 LQFP   | -40 to +85      |
| MCF52232CAF50        | MCF52232 Microcontroller                     | 50          | 128 / 32            | 80 LQFP    | -40 to +85      |
| MCF52232AF50         | MCF52232 Microcontroller                     | 50          | 128 / 32            | 80 LQFP    | 0 to +70        |
| MCF52233CAF60        | MCF52233 Microcontroller                     | 60          | 256 / 32            | 80 LQFP    | -40 to +85      |
| MCF52233CAL60        | MCF52233 Microcontroller                     | 60          | 256 / 32            | 112 LQFP   | -40 to +85      |
| MCF52233CAL60A       | MCF52233 Microcontroller                     | 60          | 256 / 32            | 112 LQFP   | -40 to +85      |
| MCF52233CVM60        | MCF52233 Microcontroller                     | 60          | 256 / 32            | 121 MAPBGA | -40 to +85      |
| MCF52234CAL60        | MCF52234 Microcontroller, FlexCAN            | 60          | 256 / 32            | 112 LQFP   | -40 to +85      |
| MCF52234CVM60        | MCF52234 Microcontroller, FlexCAN            | 60          | 256 / 32            | 121 MAPBGA | -40 to +85      |
| MCF52235CAL60        | MCF52235 Microcontroller, FlexCAN, CAU, RNGA | 60          | 256 / 32            | 112 LQFP   | -40 to +85      |
| MCF52235CAL60A       | MCF52235 Microcontroller, FlexCAN, CAU, RNGA | 60          | 256 / 32            | 112 LQFP   | -40 to +85      |
| MCF52235CVM60        | MCF52235 Microcontroller, FlexCAN, CAU, RNGA | 60          | 256 / 32            | 121 MAPBGA | -40 to +85      |
| MCF52236CAF50        | MCF52236 Microcontroller                     | 50          | 256 / 32            | 80 LQFP    | -40 to +85      |
| MCF52236AF50         | MCF52236 Microcontroller                     | 50          | 256 / 32            | 80 LQFP    | 0 to +70        |
| MCF52236AF50A        | MCF52236 Microcontroller                     | 50          | 256 / 32            | 80 LQFP    | 0 to +70        |

# 1.2.24 Package Pinouts

Figure 2 shows the pinout configuration for the 80-pin LQFP.

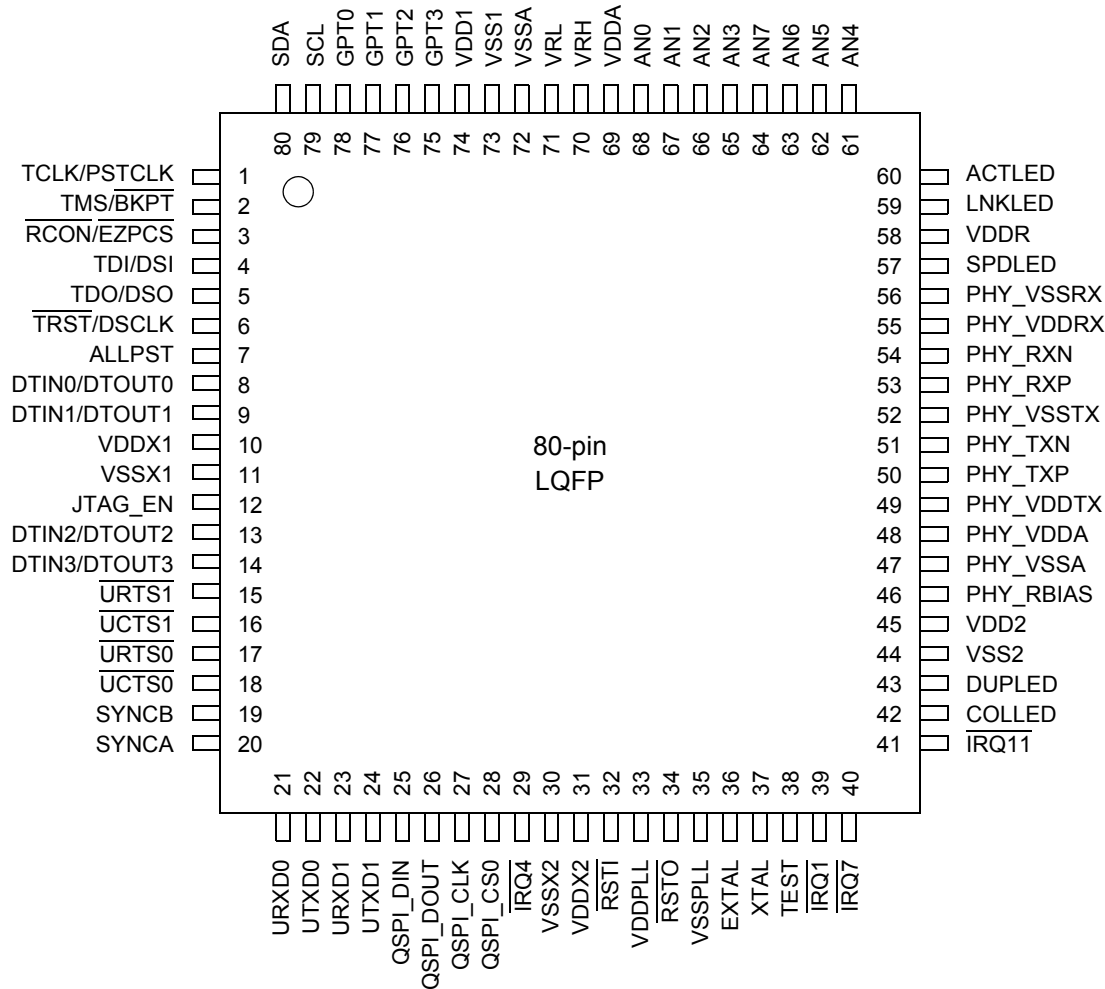


Figure 2. 80-pin LQFP Pin Assignments

Figure 3 shows the pinout configuration for the 112-pin LQFP.

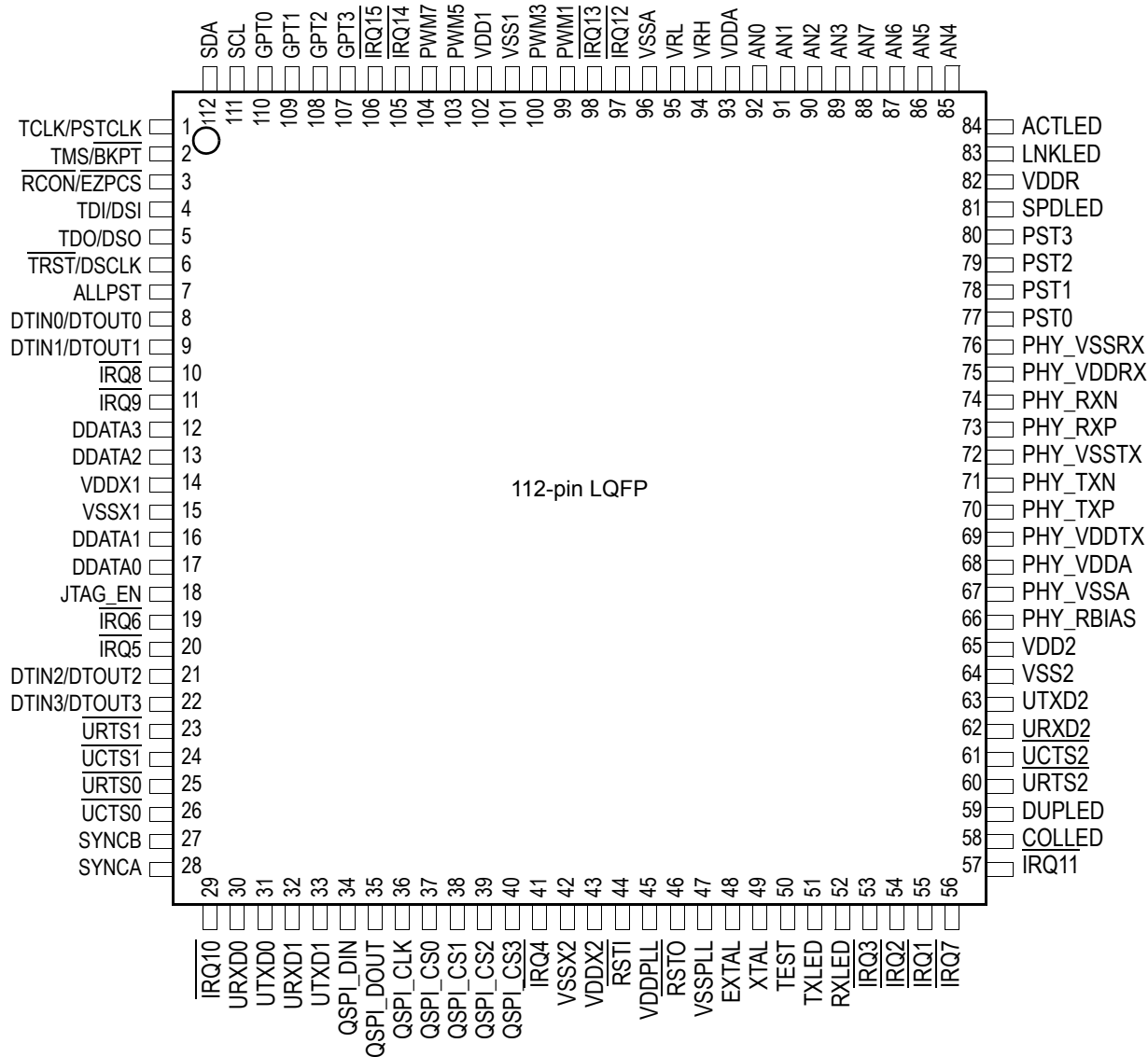


Figure 3. 112-pin LQFP Pin Assignments

Figure 4 shows the pinout configuration for the 121 MAPBGA.

|   | 1                         | 2                         | 3                         | 4                         | 5                         | 6                         | 7                         | 8                        | 9                         | 10                        | 11        |
|---|---------------------------|---------------------------|---------------------------|---------------------------|---------------------------|---------------------------|---------------------------|--------------------------|---------------------------|---------------------------|-----------|
| A | TCLK                      | SDA                       | SCL                       | $\overline{\text{IRQ15}}$ | $\overline{\text{IRQ14}}$ | $\overline{\text{IRQ13}}$ | VSSA                      | VDDA                     | AN1                       | AN7                       | AN5       |
| B | TMS                       | $\overline{\text{RCON}}$  | GPT0                      | GPT3                      | PWM5                      | PWM1                      | VRL                       | VRH                      | AN2                       | AN6                       | AN4       |
| C | $\overline{\text{TRST}}$  | TDO                       | TDI                       | GPT2                      | PWM7                      | PWM3                      | $\overline{\text{IRQ12}}$ | AN0                      | AN3                       | LNKLED                    | ACTLED    |
| D | DTIN1                     | DTIN0                     | ALLPST                    | GPT1                      | VDDX                      | VDDX                      | VDD                       | VDDR                     | PST2                      | PST3                      | SPDLED    |
| E | DDATA3                    | $\overline{\text{IRQ9}}$  | $\overline{\text{IRQ8}}$  | VSS                       | VSS                       | VDDX                      | VSS                       | VDD                      | PST0                      | PST1                      | PHY_RXN   |
| F | DDATA0                    | DDATA1                    | DDATA2                    | VSS                       | VSS                       | VSS                       | VSS                       | VSS                      | PHY_VSSRX                 | PHY_VDDR                  | PHY_RXP   |
| G | DTIN2                     | $\overline{\text{IRQ5}}$  | $\overline{\text{IRQ6}}$  | JTAG_EN                   | VDDX                      | VDDX                      | VDDX                      | PHY_VSSA                 | PHY_VSSTX                 | PHY_VDDTX                 | PHY_TXP   |
| H | DTIN3                     | $\overline{\text{URTS0}}$ | $\overline{\text{URTS1}}$ | QSPI_DIN                  | QSPI_CS1                  | VDDX                      | TEST                      | TXLED                    | RXLED                     | PHY_VDDA                  | PHY_TXN   |
| J | SYNCB                     | $\overline{\text{UCTS0}}$ | $\overline{\text{UCTS1}}$ | QSPI_DOUT                 | QSPI_CS2                  | $\overline{\text{RSTI}}$  | XTAL                      | $\overline{\text{IRQ1}}$ | COLLED                    | DUPLED                    | PHY_RBIAS |
| K | SYNCA                     | URXD0                     | URXD1                     | QSPI_CLK                  | QSPI_CS3                  | VDDPLL                    | VSSPLL                    | $\overline{\text{IRQ2}}$ | $\overline{\text{IRQ11}}$ | $\overline{\text{URTS2}}$ | URXD2     |
| L | $\overline{\text{IRQ10}}$ | UTXD0                     | UTXD1                     | QSPI_CS0                  | $\overline{\text{IRQ4}}$  | $\overline{\text{RSTO}}$  | EXTAL                     | $\overline{\text{IRQ3}}$ | $\overline{\text{IRQ7}}$  | $\overline{\text{UCTS2}}$ | UTXD2     |

Figure 4. 121 MAPBGA Pin Assignments

Table 3. Pin Functions by Primary and Alternate Purpose

| Pin Group        | Primary Function    | Secondary Function | Tertiary Function | Quaternary Function | Drive Strength/Control <sup>1</sup> | Wired OR Control | Pull-up/Pull-down <sup>2</sup> | Pin on 121 MAPBGA | Pin on 112 LQFP | Pin on 80 LQFP |
|------------------|---------------------|--------------------|-------------------|---------------------|-------------------------------------|------------------|--------------------------------|-------------------|-----------------|----------------|
| ADC <sup>3</sup> | AN7                 | —                  | —                 | PAN[7]              | Low                                 | —                | —                              | A10               | 88              | 64             |
|                  | AN6                 | —                  | —                 | PAN[6]              | Low                                 | —                | —                              | B10               | 87              | 63             |
|                  | AN5                 | —                  | —                 | PAN[5]              | Low                                 | —                | —                              | A11               | 86              | 62             |
|                  | AN4                 | —                  | —                 | PAN[4]              | Low                                 | —                | —                              | B11               | 85              | 61             |
|                  | AN3                 | —                  | —                 | PAN[3]              | Low                                 | —                | —                              | C9                | 89              | 65             |
|                  | AN2                 | —                  | —                 | PAN[2]              | Low                                 | —                | —                              | B9                | 90              | 66             |
|                  | AN1                 | —                  | —                 | PAN[1]              | Low                                 | —                | —                              | A9                | 91              | 67             |
|                  | AN0                 | —                  | —                 | PAN[0]              | Low                                 | —                | —                              | C8                | 92              | 68             |
|                  | SYNCA               | CANTX <sup>4</sup> | FEC_MDIO          | PAS[3]              | PDSR[39]                            | —                | —                              | K1                | 28              | 20             |
|                  | SYNCB               | CANRX <sup>4</sup> | FEC_MDC           | PAS[2]              | PDSR[39]                            | —                | —                              | J1                | 27              | 19             |
|                  | VDDA                | —                  | —                 | —                   | N/A                                 | N/A              | —                              | A8                | 93              | 69             |
|                  | VSSA                | —                  | —                 | —                   | N/A                                 | N/A              | —                              | A7                | 96              | 72             |
|                  | VRH                 | —                  | —                 | —                   | N/A                                 | N/A              | —                              | B8                | 94              | 70             |
|                  | VRL                 | —                  | —                 | —                   | N/A                                 | N/A              | —                              | B7                | 95              | 71             |
| Clock Generation | EXTAL               | —                  | —                 | —                   | N/A                                 | N/A              | —                              | L7                | 48              | 36             |
|                  | XTAL                | —                  | —                 | —                   | N/A                                 | N/A              | —                              | J7                | 49              | 37             |
|                  | VDDPLL <sup>5</sup> | —                  | —                 | —                   | N/A                                 | N/A              | —                              | K6                | 45              | 33             |
|                  | VSSPLL              | —                  | —                 | —                   | N/A                                 | N/A              | —                              | K7                | 47              | 35             |
| Debug Data       | ALLPST              | —                  | —                 | —                   | High                                | —                | —                              | D3                | 7               | 7              |
|                  | DDATA[3:0]          | —                  | —                 | PDD[7:4]            | High                                | —                | —                              | E1, F3,F2, F1     | 12,13,16,17     | —              |
|                  | PST[3:0]            | —                  | —                 | PDD[3:0]            | High                                | —                | —                              | D10, D9, E10, E9  | 80,79,78,77     | —              |

Table 3. Pin Functions by Primary and Alternate Purpose (continued)

| Pin Group               | Primary Function       | Secondary Function | Tertiary Function | Quaternary Function | Drive Strength/Control <sup>1</sup> | Wired OR Control | Pull-up/Pull-down <sup>2</sup> | Pin on 121 MAPBGA | Pin on 112 LQFP | Pin on 80 LQFP |
|-------------------------|------------------------|--------------------|-------------------|---------------------|-------------------------------------|------------------|--------------------------------|-------------------|-----------------|----------------|
| Ethernet LEDs           | ACTLED                 | —                  | —                 | PLD[0]              | PDSR[32]                            | PWOR[8]          | —                              | C11               | 84              | 60             |
|                         | COLLED                 | —                  | —                 | PLD[4]              | PDSR[36]                            | PWOR[12]         | —                              | J9                | 58              | 42             |
|                         | DUPLED                 | —                  | —                 | PLD[3]              | PDSR[35]                            | PWOR[11]         | —                              | J10               | 59              | 43             |
|                         | LNKLED                 | —                  | —                 | PLD[1]              | PDSR[33]                            | PWOR[9]          | —                              | C10               | 83              | 59             |
|                         | SPDLED                 | —                  | —                 | PLD[2]              | PDSR[34]                            | PWOR[10]         | —                              | D11               | 81              | 57             |
|                         | RXLED                  | —                  | —                 | PLD[5]              | PDSR[37]                            | PWOR[13]         | —                              | H9                | 52              | —              |
|                         | TXLED                  | —                  | —                 | PLD[6]              | PDSR[38]                            | PWOR[14]         | —                              | H8                | 51              | —              |
|                         | VDDR                   | —                  | —                 | —                   | —                                   | —                | —                              | D8                | 82              | 58             |
| Ethernet PHY            | PHY_RBIAS              | —                  | —                 | —                   | —                                   | —                |                                | J11               | 66              | 46             |
|                         | PHY_RXN                | —                  | —                 | —                   | —                                   | —                |                                | E11               | 74              | 54             |
|                         | PHY_RXP                | —                  | —                 | —                   | —                                   | —                |                                | F11               | 73              | 53             |
|                         | PHY_TXN                | —                  | —                 | —                   | —                                   | —                |                                | H11               | 71              | 51             |
|                         | PHY_TXP                | —                  | —                 | —                   | —                                   | —                |                                | G11               | 70              | 50             |
|                         | PHY_VDDA <sup>5</sup>  | —                  | —                 | —                   |                                     | N/A              |                                | H10               | 68              | 48             |
|                         | PHY_VDDRX <sup>5</sup> | —                  | —                 | —                   |                                     | N/A              |                                | F10               | 75              | 55             |
|                         | PHY_VDDTX <sup>5</sup> | —                  | —                 | —                   |                                     | N/A              |                                | G10               | 69              | 49             |
|                         | PHY_VSSA               | —                  | —                 | —                   |                                     | N/A              |                                | G8                | 67              | 47             |
|                         | PHY_VSSRX              | —                  | —                 | —                   |                                     | N/A              |                                | F9                | 76              | 56             |
|                         | PHY_VSSTX              | —                  | —                 | —                   |                                     | N/A              |                                | G9                | 72              | 52             |
| I <sup>2</sup> C        | SCL                    | CANTX <sup>4</sup> | UTXD2             | PAS[0]              | PDSR[0]                             | —                | Pull-Up <sup>6</sup>           | A3                | 111             | 79             |
|                         | SDA                    | CANRX <sup>4</sup> | URXD2             | PAS[1]              | PDSR[0]                             | —                | Pull-Up <sup>6</sup>           | A2                | 112             | 80             |
| Interrupts <sup>3</sup> | IRQ15                  | —                  | —                 | PGP[7]              | PSDR[47]                            | —                | Pull-Up <sup>6</sup>           | A4                | 106             | —              |
|                         | IRQ14                  | —                  | —                 | PGP[6]              | PSDR[46]                            | —                | Pull-Up <sup>6</sup>           | A5                | 105             | —              |
|                         | IRQ13                  | —                  | —                 | PGP[5]              | PSDR[45]                            | —                | Pull-Up <sup>6</sup>           | A6                | 98              | —              |
|                         | IRQ12                  | —                  | —                 | PGP[4]              | PSDR[44]                            | —                | Pull-Up <sup>6</sup>           | C7                | 97              | —              |

Table 3. Pin Functions by Primary and Alternate Purpose (continued)

| Pin Group                         | Primary Function | Secondary Function | Tertiary Function | Quaternary Function | Drive Strength/Control <sup>1</sup> | Wired OR Control | Pull-up/Pull-down <sup>2</sup> | Pin on 121 MAPBGA | Pin on 112 LQFP | Pin on 80 LQFP |
|-----------------------------------|------------------|--------------------|-------------------|---------------------|-------------------------------------|------------------|--------------------------------|-------------------|-----------------|----------------|
| Continued Interrupts <sup>3</sup> | IRQ11            | —                  | —                 | PGP[3]              | PSDR[43]                            | —                | Pull-Up <sup>6</sup>           | K9                | 57              | 41             |
|                                   | IRQ10            | —                  | —                 | PGP[2]              | PSDR[42]                            | —                | Pull-Up <sup>6</sup>           | L1                | 29              | —              |
|                                   | IRQ9             | —                  | —                 | PGP[1]              | PSDR[41]                            | —                | Pull-Up <sup>6</sup>           | E2                | 11              | —              |
|                                   | IRQ8             | —                  | —                 | PGP[0]              | PSDR[40]                            | —                | Pull-Up                        | E3                | 10              | —              |
|                                   | IRQ7             | —                  | —                 | PNQ[7]              | Low                                 | —                | Pull-Up <sup>6</sup>           | L9                | 56              | 40             |
|                                   | IRQ6             | —                  | FEC_RXER          | PNQ[6]              | Low                                 | —                | Pull-Up <sup>6</sup>           | G3                | 19              | —              |
|                                   | IRQ5             | —                  | FEC_RXD[1]        | PNQ[5]              | Low                                 | —                | Pull-Up <sup>6</sup>           | G2                | 20              | —              |
|                                   | IRQ4             | —                  | —                 | PNQ[4]              | Low                                 | —                | Pull-Up <sup>6</sup>           | L5                | 41              | 29             |
|                                   | IRQ3             | —                  | FEC_RXD[2]        | PNQ[3]              | Low                                 | —                | Pull-Up <sup>6</sup>           | L8                | 53              | —              |
|                                   | IRQ2             | —                  | FEC_RXD[3]        | PNQ[2]              | Low                                 | —                | Pull-Up <sup>6</sup>           | K8                | 54              | —              |
|                                   | IRQ1             | SYNCA              | PWM1              | PNQ[1]              | High                                | —                | Pull-Up <sup>6</sup>           | J8                | 55              | 39             |
| JTAG/BDM                          | JTAG_EN          | —                  | —                 | —                   | N/A                                 | N/A              | Pull-Down                      | G4                | 18              | 12             |
|                                   | TCLK/PSTCLK      | CLKOUT             | —                 | —                   | High                                | —                | Pull-Up <sup>7</sup>           | A1                | 1               | 1              |
|                                   | TDI/DSI          | —                  | —                 | —                   | N/A                                 | N/A              | Pull-Up <sup>7</sup>           | C3                | 4               | 4              |
|                                   | TDO/DSO          | —                  | —                 | —                   | High                                | N/A              | —                              | C2                | 5               | 5              |
|                                   | TMS/BKPT         | —                  | —                 | —                   | N/A                                 | N/A              | Pull-Up <sup>7</sup>           | B1                | 2               | 2              |
|                                   | TRST/DSCLK       | —                  | —                 | —                   | N/A                                 | N/A              | Pull-Up                        | C1                | 6               | 6              |
| Mode Selection                    | RCON/EZPCS       | —                  | —                 | —                   | N/A                                 | N/A              | Pull-Up                        | B2                | 3               | 3              |
| PWM                               | PWM7             | —                  | —                 | PTD[3]              | PDSR[31]                            | —                | —                              | C5                | 104             | —              |
|                                   | PWM5             | —                  | —                 | PTD[2]              | PDSR[30]                            | —                | —                              | B5                | 103             | —              |
|                                   | PWM3             | —                  | —                 | PTD[1]              | PDSR[29]                            | —                | —                              | C6                | 100             | —              |
|                                   | PWM1             | —                  | —                 | PTD[0]              | PDSR[28]                            | —                | —                              | B6                | 99              | —              |

Table 3. Pin Functions by Primary and Alternate Purpose (continued)

| Pin Group                   | Primary Function   | Secondary Function | Tertiary Function | Quaternary Function | Drive Strength/Control <sup>1</sup> | Wired OR Control | Pull-up/Pull-down <sup>2</sup> | Pin on 121 MAPBGA | Pin on 112 LQFP | Pin on 80 LQFP |
|-----------------------------|--------------------|--------------------|-------------------|---------------------|-------------------------------------|------------------|--------------------------------|-------------------|-----------------|----------------|
| QSPI <sup>3</sup>           | QSPI_DIN/EZPD      | CANRX <sup>4</sup> | URXD1             | PQS[1]              | PDSR[2]                             | PWOR[4]          | —                              | H4                | 34              | 25             |
|                             | QSPI_DOUT/EZPQ     | CANTX <sup>4</sup> | UTXD1             | PQS[0]              | PDSR[1]                             | PWOR[5]          | —                              | J4                | 35              | 26             |
|                             | QSPI_CLK/EZPCK     | SCL                | URTS1             | PQS[2]              | PDSR[3]                             | PWOR[6]          | Pull-Up <sup>8</sup>           | K4                | 36              | 27             |
|                             | QSPI_CS3           | SYNCA              | SYNCB             | PQS[6]              | PDSR[7]                             | —                | —                              | K5                | 40              | —              |
|                             | QSPI_CS2           | —                  | FEC_TXCLK         | PQS[5]              | PDSR[6]                             | —                | —                              | J5                | 39              | —              |
|                             | QSPI_CS1           | —                  | FEC_TXEN          | PQS[4]              | PDSR[5]                             | —                | —                              | H5                | 38              | —              |
|                             | QSPI_CS0           | SDA                | UCTS1             | PQS[3]              | PDSR[4]                             | PWOR[7]          | Pull-Up <sup>8</sup>           | L4                | 37              | 28             |
| Reset <sup>9</sup>          | RSTI               | —                  | —                 | —                   | N/A                                 | N/A              | Pull-Up <sup>9</sup>           | J6                | 44              | 32             |
|                             | RSTO               | —                  | —                 | —                   | high                                | —                | —                              | L6                | 46              | 34             |
| Test                        | TEST               | —                  | —                 | —                   | N/A                                 | N/A              | Pull-Down                      | H7                | 50              | 38             |
| Timers, 16-bit <sup>3</sup> | GPT3               | FEC_TXD[3]         | PWM7              | PTA[3]              | PDSR[23]                            | —                | Pull-Up <sup>10</sup>          | B4                | 107             | 75             |
|                             | GPT2               | FEC_TXD[2]         | PWM5              | PTA[2]              | PDSR[22]                            | —                | Pull-Up <sup>10</sup>          | C4                | 108             | 76             |
|                             | GPT1               | FEC_TXD[1]         | PWM3              | PTA[1]              | PDSR[21]                            | —                | Pull-Up <sup>10</sup>          | D4                | 109             | 77             |
|                             | GPT0               | FEC_TXER           | PWM1              | PTA[0]              | PDSR[20]                            | —                | Pull-Up <sup>10</sup>          | B3                | 110             | 78             |
| Timers, 32-bit              | DTIN3              | DTOUT3             | PWM6              | PTC[3]              | PDSR[19]                            | —                | —                              | H1                | 22              | 14             |
|                             | DTIN2              | DTOUT2             | PWM4              | PTC[2]              | PDSR[18]                            | —                | —                              | G1                | 21              | 13             |
|                             | DTIN1              | DTOUT1             | PWM2              | PTC[1]              | PDSR[17]                            | —                | —                              | D1                | 9               | 9              |
|                             | DTIN0              | DTOUT0             | PWM0              | PTC[0]              | PDSR[16]                            | —                | —                              | D2                | 8               | 8              |
| UART 0 <sup>3</sup>         | $\overline{UCTS0}$ | CANRX <sup>4</sup> | FEC_RXCLK         | PUA[3]              | PDSR[11]                            | —                | —                              | J2                | 26              | 18             |
|                             | $\overline{URTS0}$ | CANTX <sup>4</sup> | FEC_RXDV          | PUA[2]              | PDSR[10]                            | —                | —                              | H2                | 25              | 17             |
|                             | URXD0              | —                  | FEC_RXD[0]        | PUA[1]              | PDSR[9]                             | PWOR[0]          | —                              | K2                | 30              | 21             |
|                             | UTXD0              | —                  | FEC_CRX           | PUA[0]              | PDSR[8]                             | PWOR[1]          | —                              | L2                | 31              | 22             |

Table 3. Pin Functions by Primary and Alternate Purpose (continued)

| Pin Group           | Primary Function          | Secondary Function | Tertiary Function | Quaternary Function | Drive Strength/Control <sup>1</sup> | Wired OR Control | Pull-up/Pull-down <sup>2</sup> | Pin on 121 MAPBGA              | Pin on 112 LQFP | Pin on 80 LQFP |
|---------------------|---------------------------|--------------------|-------------------|---------------------|-------------------------------------|------------------|--------------------------------|--------------------------------|-----------------|----------------|
| UART 1 <sup>3</sup> | $\overline{\text{UCTS1}}$ | SYNCA              | URXD2             | PUB[3]              | PDSR[15]                            | —                | —                              | J3                             | 24              | 16             |
|                     | $\overline{\text{URTS1}}$ | SYNCB              | UTXD2             | PUB[2]              | PDSR[14]                            | —                | —                              | H3                             | 23              | 15             |
|                     | URXD1                     | —                  | FEC_TXD[0]        | PUB[1]              | PDSR[13]                            | PWOR[2]          | —                              | K3                             | 32              | 23             |
|                     | UTXD1                     | —                  | FEC_COL           | PUB[0]              | PDSR[12]                            | PWOR[3]          | —                              | L3                             | 33              | 24             |
| UART 2              | $\overline{\text{UCTS2}}$ | —                  | —                 | PUC[3]              | PDSR[27]                            | —                | —                              | L10                            | 61              | —              |
|                     | $\overline{\text{URTS2}}$ | —                  | —                 | PUC[2]              | PDSR[26]                            | —                | —                              | K10                            | 60              | —              |
|                     | URXD2                     | —                  | —                 | PUC[1]              | PDSR[25]                            | —                | —                              | K11                            | 62              | —              |
|                     | UTXD2                     | —                  | —                 | PUC[0]              | PDSR[24]                            | —                | —                              | L11                            | 63              | —              |
| FlexCAN             | SYNCA                     | CANTX <sup>4</sup> | FEC_MDIO          | PAS[3]              | PDSR[39]                            | —                | —                              | —                              | 28              | 20             |
|                     | SYNCB                     | CANRX <sup>4</sup> | FEC_MDC           | PAS[2]              | PDSR[39]                            | —                | —                              | —                              | 27              | 19             |
| VDD <sup>5,11</sup> | VDD                       | —                  | —                 | —                   | N/A                                 | N/A              | —                              | D7, E8                         | 65,102          | 45,74          |
| VDDX                | VDDX                      | —                  | —                 | —                   | N/A                                 | N/A              | —                              | D5, D6, E6, G5, G6, G7, H6     | 14, 43          | 10, 31         |
| VSS                 | VSS                       | —                  | —                 | —                   | N/A                                 | N/A              | —                              | E4, E5, E7, F4, F5, F6, F7, F8 | 64,101          | 44,73          |
| VSSX                | VSSX                      | —                  | —                 | —                   | N/A                                 | N/A              | —                              | —                              | 15, 42          | 11, 30         |

<sup>1</sup> The PDSR and PSSR registers are described in [Chapter 14, “General Purpose I/O Module](#). All programmable signals default to 2mA drive in normal (single-chip) mode.

<sup>2</sup> All signals have a pull-up in GPIO mode.

<sup>3</sup> The use of an external PHY limits ADC, interrupt, and QSPI functionality. It also disables the UART0/1 and timer pins.

<sup>4</sup> The multiplexed CANTX and CANRX signals do not have dedicated pins, but are available as muxed replacements for other signals.

<sup>5</sup> The VDD1, VDD2, VDDPLL, and PHY\_VDD pins are for decoupling only and should not have power directly applied to them.

<sup>6</sup> For primary and GPIO functions only.

<sup>7</sup> Only when JTAG mode is enabled.

<sup>8</sup> For secondary and GPIO functions only.

<sup>9</sup> RSTI has an internal pull-up resistor; however, the use of an external resistor is strongly recommended.

<sup>10</sup> For GPIO function. Primary Function has pull-up control within the GPT module.

<sup>11</sup> This list for power and ground does not include those dedicated power/ground pins included elsewhere, e.g. in the Ethernet PHY.

## 1.3 Reset Signals

Table 4 describes signals that are used to either reset the chip or as a reset indication.

**Table 4. Reset Signals**

| Signal Name | Abbreviation             | Function                                                                                                          | I/O |
|-------------|--------------------------|-------------------------------------------------------------------------------------------------------------------|-----|
| Reset In    | $\overline{\text{RSTI}}$ | Primary reset input to the device. Asserting $\overline{\text{RSTI}}$ immediately resets the CPU and peripherals. | I   |
| Reset Out   | $\overline{\text{RSTO}}$ | Driven low for 512 CPU clocks after the reset source has deasserted.                                              | O   |

## 1.4 PLL and Clock Signals

Table 5 describes signals that are used to support the on-chip clock generation circuitry.

**Table 5. PLL and Clock Signals**

| Signal Name       | Abbreviation | Function                                               | I/O |
|-------------------|--------------|--------------------------------------------------------|-----|
| External Clock In | EXTAL        | Crystal oscillator or external clock input.            | I   |
| Crystal           | XTAL         | Crystal oscillator output.                             | O   |
| Clock Out         | CLKOUT       | This output signal reflects the internal system clock. | O   |

## 1.5 Mode Selection

Table 6 describes signals used in mode selection, Table 6 describes particular clocking modes.

**Table 6. Mode Selection Signals**

| Signal Name         | Abbreviation | Function                                                                                                                                                                                                                                        | I/O |
|---------------------|--------------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|-----|
| Reset Configuration | RCON         | The Serial Flash Programming mode is entered by asserting the RCON pin (with the TEST pin negated) as the chip comes out of reset. During this mode, the EzPort has access to the Flash memory which can be programmed from an external device. | —   |
| Test                | TEST         | Reserved for factory testing only and in normal modes of operation should be connected to VSS to prevent unintentional activation of test functions.                                                                                            | I   |

## 1.6 External Interrupt Signals

Table 7 describes the external interrupt signals.

**Table 7. External Interrupt Signals**

| Signal Name         | Abbreviation                  | Function                    | I/O |
|---------------------|-------------------------------|-----------------------------|-----|
| External Interrupts | $\overline{\text{IRQ}}[15:1]$ | External interrupt sources. | I   |

## 1.7 Queued Serial Peripheral Interface (QSPI)

Table 8 describes QSPI signals.

**Table 8. Queued Serial Peripheral Interface (QSPI) Signals**

| Signal Name                         | Abbreviation | Function                                                                                                             | I/O |
|-------------------------------------|--------------|----------------------------------------------------------------------------------------------------------------------|-----|
| QSPI Synchronous Serial Output      | QSPI_DOUT    | Provides the serial data from the QSPI and can be programmed to be driven on the rising or falling edge of QSPI_CLK. | O   |
| QSPI Synchronous Serial Data Input  | QSPI_DIN     | Provides the serial data to the QSPI and can be programmed to be sampled on the rising or falling edge of QSPI_CLK.  | I   |
| QSPI Serial Clock                   | QSPI_CLK     | Provides the serial clock from the QSPI. The polarity and phase of QSPI_CLK are programmable.                        | O   |
| Synchronous Peripheral Chip Selects | QSPI_CS[3:0] | QSPI peripheral chip selects that can be programmed to be active high or low.                                        | O   |

## 1.8 Fast Ethernet Controller EPHY Signals

Table 9 describes the Fast Ethernet Controller (FEC) signals.

**Table 9. Fast Ethernet Controller (FEC) Signals**

| Signal Name           | Abbreviation | Function                                                                                                                                                                                                                                                                                                       | I/O |
|-----------------------|--------------|----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|-----|
| Twisted Pair Input +  | RXP          | Differential Ethernet twisted-pair input pin. This pin is high-impedance out of reset.                                                                                                                                                                                                                         | I   |
| Twisted Pair Input -  | RXN          | Differential Ethernet twisted-pair input pin. This pin is high-impedance out of reset.                                                                                                                                                                                                                         | I   |
| Twisted Pair Output + | TXN          | Differential Ethernet twisted-pair output pin. This pin is high-impedance out of reset.                                                                                                                                                                                                                        | O   |
| Twisted Pair Output - | TXP          | Differential Ethernet twisted-pair output pin. This pin is high-impedance out of reset.                                                                                                                                                                                                                        | O   |
| Bias Control Resistor | RBIAS        | Connect a 12.4 k $\Omega$ (1.0%) external resistor, RBIAS, between the PHY_RBIAS pin and analog ground. Place this resistor as near to the chip pin as possible. Stray capacitance must be kept to less than 10 pF (>50 pF causes instability). No high-speed signals can be permitted in the region of RBIAS. | I   |
| Activity LED          | ACT_LED      | Indicates when the EPHY is transmitting or receiving                                                                                                                                                                                                                                                           | O   |
| Link LED              | LINK_LED     | Indicates when the EPHY has a valid link                                                                                                                                                                                                                                                                       | O   |
| Speed LED             | SPD_LED      | Indicates the speed of the EPHY connection                                                                                                                                                                                                                                                                     | O   |
| Duplex LED            | DUPLED       | Indicates the duplex (full or half) of the EPHY connection                                                                                                                                                                                                                                                     | O   |
| Collision LED         | COLLED       | Indicates if the EPHY detects a collision                                                                                                                                                                                                                                                                      | O   |
| Transmit LED          | TXLED        | Indicates if the EPHY is transmitting                                                                                                                                                                                                                                                                          | O   |
| Receive LED           | RXLED        | Indicates if the EPHY is receiving                                                                                                                                                                                                                                                                             | O   |

## 1.9 I<sup>2</sup>C I/O Signals

Table 10 describes the I<sup>2</sup>C serial interface module signals.

**Table 10. I<sup>2</sup>C I/O Signals**

| Signal Name  | Abbreviation | Function                                                                                                                                                                                                                        | I/O |
|--------------|--------------|---------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|-----|
| Serial Clock | SCL          | Open-drain clock signal for the for the I <sup>2</sup> C interface. Either it is driven by the I <sup>2</sup> C module when the bus is in master mode or it becomes the clock input when the I <sup>2</sup> C is in slave mode. | I/O |
| Serial Data  | SDA          | Open-drain signal that serves as the data input/output for the I <sup>2</sup> C interface.                                                                                                                                      | I/O |

## 1.10 UART Module Signals

Table 11 describes the UART module signals.

**Table 11. UART Module Signals**

| Signal Name                 | Abbreviation               | Function                                                                                                                                                                                                                                                          | I/O |
|-----------------------------|----------------------------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|-----|
| Transmit Serial Data Output | UTXD <sub>n</sub>          | Transmitter serial data outputs for the UART modules. The output is held high (mark condition) when the transmitter is disabled, idle, or in the local loopback mode. Data is shifted out, LSB first, on this pin at the falling edge of the serial clock source. | O   |
| Receive Serial Data Input   | URXD <sub>n</sub>          | Receiver serial data inputs for the UART modules. Data is received on this pin LSB first. When the UART clock is stopped for power-down mode, any transition on this pin restarts it.                                                                             | I   |
| Clear-to-Send               | $\overline{\text{UCTS}}_n$ | Indicate to the UART modules that they can begin data transmission.                                                                                                                                                                                               | I   |
| Request-to-Send             | $\overline{\text{URTS}}_n$ | Automatic request-to-send outputs from the UART modules. This signal can also be configured to be asserted and negated as a function of the Rx FIFO level.                                                                                                        | O   |

## 1.11 DMA Timer Signals

Table 12 describes the signals of the four DMA timer modules.

**Table 12. DMA Timer Signals**

| Signal Name      | Abbreviation       | Function                                        | I/O |
|------------------|--------------------|-------------------------------------------------|-----|
| DMA Timer Input  | DTIN <sub>n</sub>  | Event input to the DMA timer modules.           | I   |
| DMA Timer Output | DTOUT <sub>n</sub> | Programmable output from the DMA timer modules. | O   |

## 1.12 ADC Signals

Table 13 describes the signals of the Analog-to-Digital Converter.

**Table 13. ADC Signals**

| Signal Name      | Abbreviation     | Function                                          | I/O |
|------------------|------------------|---------------------------------------------------|-----|
| Analog Inputs    | AN[7:0]          | Inputs to the A-to-D converter.                   | I   |
| Analog Reference | V <sub>RH</sub>  | Reference voltage high and low inputs.            | I   |
|                  | V <sub>RL</sub>  |                                                   | I   |
| Analog Supply    | V <sub>DDA</sub> | Isolate the ADC circuitry from power supply noise | —   |
|                  | V <sub>SSA</sub> |                                                   | —   |

## 1.13 General Purpose Timer Signals

Table 14 describes the General Purpose Timer Signals.

**Table 14. GPT Signals**

| Signal Name                        | Abbreviation | Function                                                   | I/O |
|------------------------------------|--------------|------------------------------------------------------------|-----|
| General Purpose Timer Input/Output | GPT[3:0]     | Inputs to or outputs from the general purpose timer module | I/O |

## 1.14 Pulse Width Modulator Signals

Table 15 describes the PWM signals.

**Table 15. PWM Signals**

| Signal Name         | Abbreviation | Function                                      | I/O |
|---------------------|--------------|-----------------------------------------------|-----|
| PWM Output Channels | PWM[7:0]     | Pulse width modulated output for PWM channels | O   |

## 1.15 Debug Support Signals

These signals are used as the interface to the on-chip JTAG controller and also to interface to the BDM logic.

**Table 16. Debug Support Signals**

| Signal Name      | Abbreviation             | Function                                                                                | I/O |
|------------------|--------------------------|-----------------------------------------------------------------------------------------|-----|
| JTAG Enable      | JTAG_EN                  | Select between debug module and JTAG signals at reset                                   | I   |
| Test Reset       | $\overline{\text{TRST}}$ | This active-low signal is used to initialize the JTAG logic asynchronously.             | I   |
| Test Clock       | TCLK                     | Used to synchronize the JTAG logic.                                                     | I   |
| Test Mode Select | TMS                      | Used to sequence the JTAG state machine. TMS is sampled on the rising edge of TCLK.     | I   |
| Test Data Input  | TDI                      | Serial input for test instructions and data. TDI is sampled on the rising edge of TCLK. | I   |

Table 16. Debug Support Signals (continued)

| Signal Name                  | Abbreviation             | Function                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                   | I/O |
|------------------------------|--------------------------|------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|-----|
| Test Data Output             | TDO                      | Serial output for test instructions and data. TDO is tri-stateable and is actively driven in the shift-IR and shift-DR controller states. TDO changes on the falling edge of TCLK.                                                                                                                                                                                                                                                                                                                                                                                                                                                                         | O   |
| Development Serial Clock     | DSCLK                    | Development Serial Clock. Internally synchronized input. (The logic level on DSCLK is validated if it has the same value on two consecutive rising bus clock edges.) Clocks the serial communication port to the debug module during packet transfers. Maximum frequency is PSTCLK/5. At the synchronized rising edge of DSCLK, the data input on DSI is sampled and DSO changes state.                                                                                                                                                                                                                                                                    | I   |
| Breakpoint                   | $\overline{\text{BKPT}}$ | Breakpoint. Input used to request a manual breakpoint. Assertion of $\overline{\text{BKPT}}$ puts the processor into a halted state after the current instruction completes. Halt status is reflected on processor status signals (PST[3:0]) as the value 0xF. If CSR[BKD] is set (disabling normal $\overline{\text{BKPT}}$ functionality), asserting $\overline{\text{BKPT}}$ generates a debug interrupt exception in the processor.                                                                                                                                                                                                                    | I   |
| Development Serial Input     | DSI                      | Development Serial Input. Internally synchronized input that provides data input for the serial communication port to the debug module after the DSCLK has been seen as high (logic 1).                                                                                                                                                                                                                                                                                                                                                                                                                                                                    | I   |
| Development Serial Output    | DSO                      | Development Serial Output. Provides serial output communication for debug module responses. DSO is registered internally. The output is delayed from the validation of DSCLK high.                                                                                                                                                                                                                                                                                                                                                                                                                                                                         | O   |
| Debug Data                   | DDATA[3:0]               | Display captured processor data and breakpoint status. The CLKOUT signal can be used by the development system to know when to sample DDATA[3:0].                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                          | O   |
| Processor Status Clock       | PSTCLK                   | Processor Status Clock. Delayed version of the processor clock. Its rising edge appears in the center of valid PST and DDATA output. PSTCLK indicates when the development system should sample PST and DDATA values.<br>If real-time trace is not used, setting CSR[PCD] keeps PSTCLK, PST, and DDATA outputs from toggling without disabling triggers. Non-quiescent operation can be re-enabled by clearing CSR[PCD], although the external development systems must resynchronize with the PST and DDATA outputs.<br>PSTCLK starts clocking only when the first non-zero PST value (0xC, 0xD, or 0xF) occurs during system reset exception processing. | O   |
| Processor Status Outputs     | PST[3:0]                 | Indicate core status. Debug mode timing is synchronous with the processor clock; status is unrelated to the current bus transfer. The CLKOUT signal can be used by the development system to know when to sample PST[3:0].                                                                                                                                                                                                                                                                                                                                                                                                                                 | O   |
| All Processor Status Outputs | ALLPST                   | Logical AND of PST[3:0]                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                    | O   |

## 1.16 EzPort Signal Descriptions

Table 17 contains a list of EzPort external signals

**Table 17. EzPort Signal Descriptions**

| Signal Name            | Abbreviation | Function                                                         | I/O |
|------------------------|--------------|------------------------------------------------------------------|-----|
| EzPort Clock           | EZPCK        | Shift clock for EzPort transfers                                 | I   |
| EzPort Chip Select     | EZPCS        | Chip select for signalling the start and end of serial transfers | I   |
| EzPort Serial Data In  | EZPD         | EZPD is sampled on the rising edge of EZPCK                      | I   |
| EzPort Serial Data Out | EZPQ         | EZPQ transitions on the falling edge of EZPCK                    | O   |

## 1.17 Power and Ground Pins

The pins described in Table 18 provide system power and ground to the chip. Multiple pins are provided for adequate current capability. All power supply pins must have adequate bypass capacitance for high-frequency noise suppression.

**Table 18. Power and Ground Pins**

| Signal Name       | Abbreviation   | Function                                                                                                                                          | I/O |
|-------------------|----------------|---------------------------------------------------------------------------------------------------------------------------------------------------|-----|
| PLL Analog Supply | VDDPLL, VSSPLL | Dedicated power supply signals to isolate the sensitive PLL analog circuitry from the normal levels of noise present on the digital power supply. | I   |
| Positive Supply   | VDD            | These pins supply positive power to the core logic.                                                                                               | I   |
| Ground            | VSS            | This pin is the negative supply (ground) to the chip.                                                                                             | —   |

Some of the  $V_{DD}$  and  $V_{SS}$  pins on the device are only to be used for noise bypass. Figure 5 shows a typical connection diagram. Pay particular attention to those pins which show only capacitor connections. Do not connect power supply voltage directly to these pins.

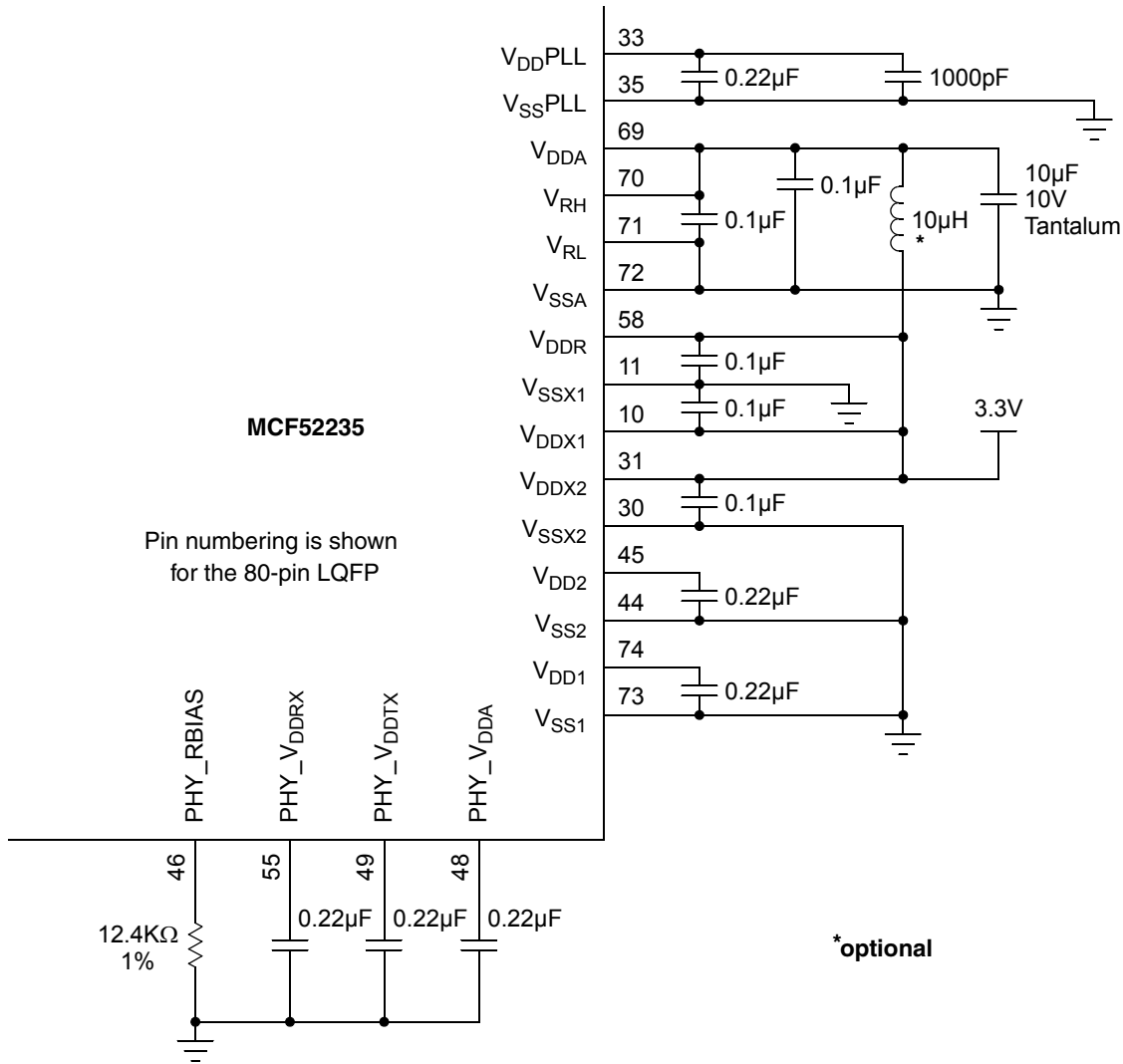


Figure 5. Suggested Connection Scheme for Power and Ground

## 2 Electrical Characteristics

This section contains electrical specification tables and reference timing diagrams for the MCF52235, including detailed information on power considerations, DC/AC electrical characteristics, and AC timing specifications.

### NOTE

The parameters specified in this appendix supersede any values found in the module specifications.

## 2.1 Maximum Ratings

**Table 19. Absolute Maximum Ratings<sup>1, 2</sup>**

| Rating                                                                                  | Symbol                   | Value         | Unit |
|-----------------------------------------------------------------------------------------|--------------------------|---------------|------|
| Supply voltage                                                                          | $V_{DD}$                 | −0.3 to +4.0  | V    |
| Clock synthesizer supply voltage                                                        | $V_{DDPLL}$              | −0.3 to +4.0  | V    |
| Digital input voltage <sup>3</sup>                                                      | $V_{IN}$                 | −0.3 to + 4.0 | V    |
| EXTAL pin voltage                                                                       | $V_{EXTAL}$              | 0 to 3.3      | V    |
| XTAL pin voltage                                                                        | $V_{XTAL}$               | 0 to 3.3      | V    |
| Instantaneous maximum current<br>Single pin limit (applies to all pins) <sup>4, 5</sup> | $I_{DD}$                 | 25            | mA   |
| Operating temperature range (packaged)                                                  | $T_A$<br>( $T_L - T_H$ ) | −40 to 85     | °C   |
| Storage temperature range                                                               | $T_{stg}$                | −65 to 150    | °C   |

<sup>1</sup> Functional operating conditions are given in DC Electrical Specifications. Absolute Maximum Ratings are stress ratings only, and functional operation at the maxima is not guaranteed. Stress beyond those listed may affect device reliability or cause permanent damage to the device.

<sup>2</sup> This device contains circuitry protecting against damage due to high static voltage or electrical fields; however, it is advised that normal precautions be taken to avoid application of any voltages higher than maximum-rated voltages to this high-impedance circuit. Reliability of operation is enhanced if unused inputs are tied to an appropriate logic voltage level (e.g., either  $V_{SS}$  or  $V_{DD}$ ).

<sup>3</sup> Input must be current limited to the  $I_{DD}$  value specified. To determine the value of the required current-limiting resistor, calculate resistance values for positive and negative clamp voltages, then use the larger of the two values.

<sup>4</sup> All functional non-supply pins are internally clamped to  $V_{SS}$  and  $V_{DD}$ .

<sup>5</sup> The power supply must maintain regulation within operating  $V_{DD}$  range during instantaneous and operating maximum current conditions. If positive injection current ( $V_{in} > V_{DD}$ ) is greater than  $I_{DD}$ , the injection current may flow out of  $V_{DD}$  and could result in external power supply going out of regulation. Ensure external  $V_{DD}$  load shunts current greater than maximum injection current. This is the greatest risk when the MCU is not consuming power (ex; no clock). The power supply must maintain regulation within operating  $V_{DD}$  range during instantaneous and operating maximum current conditions.

Table 20 lists thermal resistance values.

### NOTE

The use of this device in one- or two-layer board designs is not recommended due to the limited thermal conductance provided by those boards.

**Table 20. Thermal Characteristics**

| Characteristic                                 | Symbol         | Package <sup>1</sup>                       | Value               | Unit |
|------------------------------------------------|----------------|--------------------------------------------|---------------------|------|
| Junction to ambient, natural convection        | $\theta_{JA}$  | 80-pin LQFP, four-layer board              | 36.0 <sup>2,3</sup> | °C/W |
|                                                |                | 112-pin LQFP, four-layer board             | 35.0                |      |
|                                                |                | 121 MAPBGA, four-layer board               | 32                  |      |
|                                                |                | 80-pin LQFP, one-layer board <sup>1</sup>  | 49.0 <sup>1</sup>   |      |
|                                                |                | 121 MAPBGA, one-layer board <sup>1</sup>   | 56 <sup>1</sup>     |      |
|                                                |                | 112-pin LQFP, one-layer board <sup>1</sup> | 44.0 <sup>1</sup>   |      |
| Junction to ambient (@200 ft/min)              | $\theta_{JMA}$ | 80-pin LQFP, four-layer board              | 30.0                | °C/W |
|                                                |                | 112-pin LQFP, four-layer board             | 29.0                |      |
|                                                |                | 121 MAPBGA, four-layer board               | 28                  |      |
|                                                |                | 80-pin LQFP, one-layer board <sup>1</sup>  | 39.0 <sup>1</sup>   |      |
|                                                |                | 112-pin LQFP, one-layer board <sup>1</sup> | 35.0 <sup>1</sup>   |      |
|                                                |                | 121 MAPBGA, one-layer board <sup>1</sup>   | 46 <sup>1</sup>     |      |
| Junction to board                              | $\theta_{JB}$  | 80-pin LQFP                                | 22.0 <sup>4</sup>   | °C/W |
|                                                |                | 112-pin LQFP                               | 23.0                |      |
|                                                |                | 121 MAPBGA, four-layer board               | 18                  |      |
| Junction to case                               | $\theta_{JC}$  | 80-pin LQFP                                | 6.0 <sup>5</sup>    | °C/W |
|                                                |                | 112-pin LQFP                               | 6.0                 |      |
|                                                |                | 121 MAPBGA                                 | 10                  |      |
| Junction to top of package, natural convection | $\Psi_{jt}$    | 80-pin LQFP                                | 2.0 <sup>6</sup>    | °C/W |
|                                                |                | 112-pin LQFP                               | 2.0 <sup>6</sup>    |      |
|                                                |                | 121 MAPBGA                                 | 2.0 <sup>6</sup>    |      |
| Maximum operating junction temperature         | $T_j$          | All                                        | 130                 | °C   |

<sup>1</sup> The use of this device in one- or two-layer board designs is not recommended due to the limited thermal conductance provided by those boards.

<sup>2</sup>  $\theta_{JMA}$  and  $\Psi_{jt}$  parameters are simulated in conformance with EIA/JESD Standard 51-2 for natural convection. Freescale recommends the use of  $\theta_{JMA}$  and power dissipation specifications in the system design to prevent device junction temperatures from exceeding the rated specification. System designers should be aware that device junction temperatures can be significantly influenced by board layout and surrounding devices. Conformance to the device junction temperature specification can be verified by physical measurement in the customer's system using the  $\Psi_{jt}$  parameter, the device power dissipation, and the method described in EIA/JESD Standard 51-2.

<sup>3</sup> Per JEDEC JESD51-6 with the board horizontal.

<sup>4</sup> Thermal resistance between the die and the printed circuit board in conformance with JEDEC JESD51-8. Board temperature is measured on the top surface of the board near the package.

<sup>5</sup> Thermal resistance between the die and the case top surface as measured by the cold plate method (MIL SPEC-883 Method 1012.1).

<sup>6</sup> Thermal characterization parameter indicating the temperature difference between package top and the junction temperature per JEDEC JESD51-2. When Greek letters are not available, the thermal characterization parameter is written in conformance with Psi-JT.

The average chip-junction temperature ( $T_J$ ) in °C can be obtained from

$$T_J = T_A + (P_D \times \Theta_{JMA}) \quad \text{Eqn. 1}$$

where

- $T_A$  = ambient temperature, °C
- $\Theta_{JMA}$  = package thermal resistance, junction-to-ambient, °C/W
- $P_D = P_{INT} + P_{I/O}$
- $P_{INT}$  = chip internal power,  $I_{DD} \times V_{DD}$ , watts
- $P_{I/O}$  = power dissipation on input and output pins — user determined

For most applications,  $P_{I/O} < P_{INT}$  and can be ignored. An approximate relationship between  $P_D$  and  $T_J$  (if  $P_{I/O}$  is neglected) is:

$$P_D = K \div (T_J + 273^\circ\text{C}) \quad \text{Eqn. 2}$$

Solving equations 1 and 2 for K gives:

$$K = P_D \times (T_A + 273^\circ\text{C}) + \Theta_{JMA} \times P_D^2 \quad \text{Eqn. 3}$$

where K is a constant pertaining to the particular part. K can be determined from Equation 3 by measuring  $P_D$  (at equilibrium) for a known  $T_A$ . Using this value of K, the values of  $P_D$  and  $T_J$  can be obtained by solving Equation 1 and Equation 2 iteratively for any value of  $T_A$ .

## 2.2 ESD Protection

**Table 21. ESD Protection Characteristics<sup>1</sup>**

| Characteristic                      | Symbol       | Value                                             | Units |
|-------------------------------------|--------------|---------------------------------------------------|-------|
| ESD target for Human Body Model     | HBM          | 1500 (ADC and EPHY pins)<br>2000 (All other pins) | V     |
| ESD target for Charged Device Model | CDM          | 250                                               | V     |
| HBM circuit description             | $R_{series}$ | 1500                                              | ohms  |
|                                     | C            | 100                                               | pF    |
| Number of pulses per pin (HBM)      |              |                                                   |       |
| positive pulses                     | —            | 1                                                 | —     |
| negative pulses                     | —            | 1                                                 | —     |
| Number of pulses per pin (CDM)      |              |                                                   |       |
| positive pulses                     | —            | 3                                                 | —     |
| negative pulses                     | —            | 3                                                 | —     |
| Interval of pulses (HBM)            | —            | 1.0                                               | sec   |
| Interval of pulses (CDM)            | —            | 0.2                                               | sec   |

<sup>1</sup> A device is defined as a failure if the device no longer meets the device specification requirements after exposure to ESD pulses. Complete DC parametric and functional testing is performed per applicable device specification at room temperature followed by hot temperature, unless specified otherwise in the device specification.

## 2.3 DC Electrical Specifications

Table 22. DC Electrical Specifications <sup>1</sup>

| Characteristic                                                                                                                                                                         | Symbol       | Min                  | Max                  | Unit    |
|----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|--------------|----------------------|----------------------|---------|
| Supply voltage                                                                                                                                                                         | $V_{DD}$     | 3.0                  | 3.6                  | V       |
| Input high voltage                                                                                                                                                                     | $V_{IH}$     | $0.7 \times V_{DD}$  | 4.0                  | V       |
| Input low voltage                                                                                                                                                                      | $V_{IL}$     | $V_{SS} - 0.3$       | $0.35 \times V_{DD}$ | V       |
| Input hysteresis                                                                                                                                                                       | $V_{HYS}$    | $0.06 \times V_{DD}$ | —                    | mV      |
| Low-voltage detect trip voltage ( $V_{DD}$ falling)                                                                                                                                    | $V_{LVD}$    | 2.15                 | 2.3                  | V       |
| Low-voltage detect hysteresis ( $V_{DD}$ rising)                                                                                                                                       | $V_{LVDHYS}$ | 60                   | 120                  | mV      |
| Input leakage current<br>$V_{in} = V_{DD}$ or $V_{SS}$ , input-only pins                                                                                                               | $I_{in}$     | -1.0                 | 1.0                  | $\mu A$ |
| High impedance (off-state) leakage current<br>$V_{in} = V_{DD}$ or $V_{SS}$ , all input/output and output pins                                                                         | $I_{OZ}$     | -1.0                 | 1.0                  | $\mu A$ |
| Output high voltage (all input/output and all output pins)<br>$I_{OH} = -2.0$ mA                                                                                                       | $V_{OH}$     | $V_{DD} - 0.5$       | —                    | V       |
| Output low voltage (all input/output and all output pins)<br>$I_{OL} = 2.0$ mA                                                                                                         | $V_{OL}$     | —                    | 0.5                  | V       |
| Weak internal pull-up device current, tested at $V_{IL}$ max. <sup>2</sup>                                                                                                             | $I_{APU}$    | -10                  | -130                 | $\mu A$ |
| Input capacitance <sup>3</sup><br>All input-only pins<br>All input/output (three-state) pins                                                                                           | $C_{in}$     | —<br>—               | 7<br>7               | pF      |
| Load capacitance <sup>4</sup><br>Low drive strength<br>High drive strength                                                                                                             | $C_L$        |                      | 25<br>50             | pF      |
| DC injection current <sup>3, 5, 6, 7</sup><br>$V_{NEGCLAMP} = V_{SS} - 0.3$ V, $V_{POSCLAMP} = V_{DD} + 0.3$<br>Single pin limit<br>Total MCU limit, Includes sum of all stressed pins | $I_{IC}$     | -1.0<br>-10          | 1.0<br>10            | mA      |

<sup>1</sup> Refer to Table 25 for additional PLL specifications.

<sup>2</sup> Refer to Table 3 for pins with internal pull-up devices.

<sup>3</sup> This parameter is characterized before qualification rather than 100% tested.

<sup>4</sup> pF load ratings are based on DC loading and are provided as an indication of driver strength. High speed interfaces require transmission line analysis to determine proper drive strength and termination.

<sup>5</sup> All functional non-supply pins are internally clamped to  $V_{SS}$  and their respective  $V_{DD}$ .

<sup>6</sup> Input must be current limited to the value specified. To determine the value of the required current-limiting resistor, calculate resistance values for positive and negative clamp voltages, then use the larger of the two values.

<sup>7</sup> The power supply must maintain regulation within operating  $V_{DD}$  range during instantaneous and operating maximum current conditions. If positive injection current ( $V_{in} > V_{DD}$ ) is greater than  $I_{DD}$ , the injection current may flow out of  $V_{DD}$  and could result in external power supply going out of regulation. Ensure that the external  $V_{DD}$  load shunts current greater than maximum injection current. This is the greatest risk when the MCU is not consuming power. Examples are: if no system clock is present, or if clock rate is very low which would reduce overall power consumption. Also, the system clock is not present during the power-up sequence until the PLL has attained lock.

Table 23. Active Current Consumption Specifications

| Characteristic                                              | Symbol                        | Typical                     |                              |                                  |                                   | Peak       | Unit          |
|-------------------------------------------------------------|-------------------------------|-----------------------------|------------------------------|----------------------------------|-----------------------------------|------------|---------------|
|                                                             |                               | Running from SRAM, EPHY Off | Running from Flash, EPHY Off | Running from Flash, EPHY 10BaseT | Running from Flash, EPHY 100BaseT |            |               |
| Active current, core and I/O<br>PLL @25 MHz<br>PLL @60 MHz  | $I_{DDR} + I_{DDX} + I_{DDA}$ | 75<br>130                   | 82<br>138                    | 150<br>220                       | 260<br>310                        | 290<br>340 | mA            |
| Analog supply current<br>Normal operation<br>Low-power STOP | $I_{DDA}$                     | 20<br>15                    | 20<br>15                     | 20<br>15                         | 20<br>15                          | 30<br>50   | mA<br>$\mu$ A |

Table 24. Current Consumption Specifications in Low-Power Modes<sup>1</sup>

| Mode <sup>2</sup>           | PLL @25 MHz (typical) <sup>3</sup> | PLL @60 MHz (typical) <sup>3</sup> | PLL @60 MHz (peak) <sup>4</sup> | Unit |
|-----------------------------|------------------------------------|------------------------------------|---------------------------------|------|
| STOP mode 3 (STPMD[1:0]=11) | 0.2                                |                                    | 1.0                             | mA   |
| STOP mode 2 (STPMD[1:0]=10) | 7                                  |                                    | —                               |      |
| STOP mode 1 (STPMD[1:0]=01) | 10                                 | 12                                 | —                               |      |
| STOP mode 0 (STPMD[1:0]=00) | 10                                 | 12                                 | —                               |      |
| WAIT                        | 16                                 | 27                                 | —                               |      |
| DOZE                        | 16                                 | 27                                 | —                               |      |
| RUN                         | 25                                 | 45                                 | —                               |      |

<sup>1</sup> All values are measured with a 3.30 V power supply.

<sup>2</sup> Refer to the “Power Management” chapter in the *MCF52235 ColdFire® Integrated Microcontroller Reference Manual* for more information on low-power modes.

<sup>3</sup> These values were obtained with CLKOUT and all peripheral clocks except for the CFM clock disabled prior to entering low-power mode. The tests were performed at room temperature. All code was executed from flash memory; running code from SRAM further reduces power consumption.

<sup>4</sup> These values were obtained with CLKOUT and all peripheral clocks enabled. All code was executed from flash memory.

## 2.4 Phase Lock Loop Electrical Specifications

**Table 25. Oscillator and PLL Electrical Specifications**
 $(V_{DD} \text{ and } V_{DDPLL} = 2.7 \text{ to } 3.6 \text{ V}, V_{SS} = V_{SSPLL} = 0 \text{ V})$ 

| Characteristic                                                                                                                                                                 | Symbol                     | Min                   | Max                          | Unit        |
|--------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|----------------------------|-----------------------|------------------------------|-------------|
| Clock Source Frequency Range of EXTAL Frequency Range<br>• Crystal<br>• External <sup>1</sup>                                                                                  | $f_{crystal}$<br>$f_{ext}$ | 0.5<br>0              | 25.0<br>60.0                 | MHz         |
| PLL reference frequency range                                                                                                                                                  | $f_{ref\_pll}$             | 2                     | 10.0                         | MHz         |
| System frequency <sup>2</sup><br>External clock mode<br>On-Chip PLL Frequency                                                                                                  | $f_{sys}$                  | 0<br>$f_{ref} / 32$   | 60<br>60                     | MHz         |
| Loss of reference frequency <sup>3, 5</sup>                                                                                                                                    | $f_{LOR}$                  | 100                   | 1000                         | kHz         |
| Self clocked mode frequency <sup>4, 5</sup>                                                                                                                                    | $f_{SCM}$                  | 1                     | 5                            | MHz         |
| Crystal start-up time <sup>5, 6</sup>                                                                                                                                          | $t_{cst}$                  | —                     | 10                           | ms          |
| EXTAL input high voltage<br>Crystal reference<br>External reference                                                                                                            | $V_{IHEXT}$                | $V_{DD} - 1.0$<br>2.0 | $V_{DD}$<br>3.0 <sup>7</sup> | V           |
| EXTAL input low voltage<br>Crystal reference<br>External reference                                                                                                             | $V_{ILEXT}$                | $V_{SS}$<br>$V_{SS}$  | 1.0<br>0.8                   | V           |
| XTAL output high voltage<br>$I_{OH} = 1.0 \text{ mA}$                                                                                                                          | $V_{OL}$                   | $V_{DD} - 1.0$        | —                            | V           |
| XTAL output low voltage<br>$I_{OL} = 1.0 \text{ mA}$                                                                                                                           | $V_{OL}$                   | —                     | 0.5                          | V           |
| XTAL load capacitance <sup>8</sup>                                                                                                                                             |                            | —                     | —                            | pF          |
| PLL lock time <sup>5,9</sup>                                                                                                                                                   | $t_{lpll}$                 | —                     | 500                          | μs          |
| Power-up to lock time <sup>5, 7,9</sup><br>With crystal reference<br>Without crystal reference                                                                                 | $t_{lplk}$                 | —<br>—                | 10.5<br>500                  | ms<br>μs    |
| Duty cycle of reference <sup>5</sup>                                                                                                                                           | $t_{dc}$                   | 40                    | 60                           | % $f_{sys}$ |
| Frequency un-LOCK range                                                                                                                                                        | $f_{UL}$                   | -1.5                  | 1.5                          | % $f_{sys}$ |
| Frequency LOCK range                                                                                                                                                           | $f_{LCK}$                  | -0.75                 | 0.75                         | % $f_{sys}$ |
| CLKOUT period Jitter <sup>5, 6, 8, 10,11</sup> , measured at $f_{sys}$ Max<br>Peak-to-peak jitter (clock edge to clock edge)<br>Long term jitter (averaged over 2 ms interval) | $C_{jitter}$               | —<br>—                | 10<br>0.01                   | % $f_{sys}$ |

<sup>1</sup> In external clock mode, it is possible to run the chip directly from an external clock source without enabling the PLL.

<sup>2</sup> All internal registers retain data at 0 Hz.

<sup>3</sup> Loss of reference frequency is the reference frequency detected internally that transitions the PLL into self-clocked mode.

<sup>4</sup> Self-clocked mode frequency is the frequency that the PLL operates at when the reference frequency falls below  $f_{LOR}$  with default MFD/RFD settings.

<sup>5</sup> This parameter is characterized before qualification rather than 100% tested.

<sup>6</sup> Proper PC board layout procedures must be followed to achieve specifications.

- <sup>7</sup> This value has been updated
- <sup>8</sup> Load capacitance determined from crystal manufacturer specifications and include circuit board parasitics.
- <sup>9</sup> Assuming a reference is available at power up, lock time is measured from the time  $V_{DD}$  and  $V_{DDPLL}$  are valid to  $\overline{RSTO}$  negating. If the crystal oscillator is the reference for the PLL, the crystal start up time must be added to the PLL lock time to determine the total start-up time.
- <sup>10</sup> Jitter is the average deviation from the programmed frequency measured over the specified interval at maximum  $f_{sys}$ . Measurements are made with the device powered by filtered supplies and clocked by a stable external clock signal. Noise injected into the PLL circuitry via  $V_{DDPLL}$  and  $V_{SSPLL}$  and variation in crystal oscillator frequency increase the  $C_{jitter}$  percentage for a given interval
- <sup>11</sup> Based on slow system clock of 40 MHz measured at  $f_{sys}$  max.

## 2.5 General Purpose I/O Timing

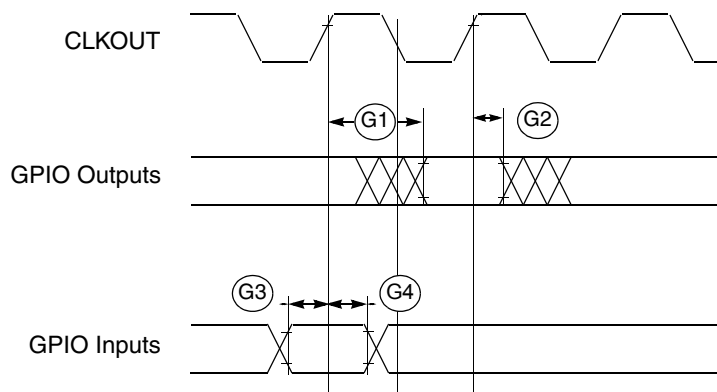
GPIO can be configured for certain pins of the QSPI, timers, UARTs, FEC, and interrupts. When in GPIO mode, the timing specification for these pins is given in [Table 26](#) and [Figure 6](#).

The GPIO timing is met under the following load test conditions:

- 50 pF / 50  $\Omega$  for high drive
- 25 pF / 25  $\Omega$  for low drive

**Table 26. GPIO Timing**

| Num | Characteristic                     | Symbol      | Min | Max | Unit |
|-----|------------------------------------|-------------|-----|-----|------|
| G1  | CLKOUT high to GPIO output valid   | $t_{CHPOV}$ | —   | 10  | ns   |
| G2  | CLKOUT high to GPIO output invalid | $t_{CHPOI}$ | 1.5 | —   | ns   |
| G3  | GPIO input valid to CLKOUT high    | $t_{PVCH}$  | 9   | —   | ns   |
| G4  | CLKOUT high to GPIO input invalid  | $t_{CHPI}$  | 1.5 | —   | ns   |



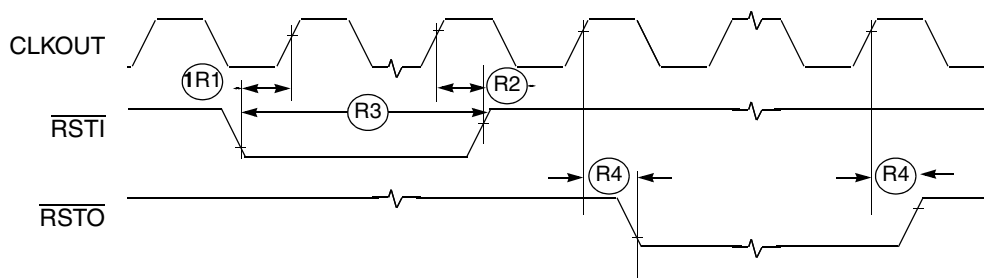
**Figure 6. GPIO Timing**

## 2.6 Reset Timing

**Table 27. Reset and Configuration Override Timing**
 $(V_{DD} = 2.7 \text{ to } 3.6 \text{ V}, V_{SS} = 0 \text{ V}, T_A = T_L \text{ to } T_H)^1$ 

| Num | Characteristic                                  | Symbol      | Min | Max | Unit      |
|-----|-------------------------------------------------|-------------|-----|-----|-----------|
| R1  | $\overline{RSTI}$ input valid to CLKOUT high    | $t_{RVCH}$  | 9   | —   | ns        |
| R2  | CLKOUT high to $\overline{RSTI}$ input invalid  | $t_{CHRI}$  | 1.5 | —   | ns        |
| R3  | $\overline{RSTI}$ input valid time <sup>2</sup> | $t_{RIVT}$  | 5   | —   | $t_{CYC}$ |
| R4  | CLKOUT high to $\overline{RSTO}$ valid          | $t_{CHROV}$ | —   | 10  | ns        |

<sup>1</sup> All AC timing is shown with respect to 50%  $V_{DD}$  levels unless otherwise noted.

<sup>2</sup> During low power STOP, the synchronizers for the  $\overline{RSTI}$  input are bypassed and  $\overline{RSTI}$  is asserted asynchronously to the system. Therefore,  $\overline{RSTI}$  must be held a minimum of 100ns.

**Figure 7.  $\overline{RSTI}$  and Configuration Override Timing**

## 2.7 I<sup>2</sup>C Input/Output Timing Specifications

Table 28 lists specifications for the I<sup>2</sup>C input timing parameters shown in Figure 8.

**Table 28. I<sup>2</sup>C Input Timing Specifications between I2C\_SCL and I2C\_SDA**

| Num | Characteristic                                                             | Min                | Max | Units |
|-----|----------------------------------------------------------------------------|--------------------|-----|-------|
| I1  | Start condition hold time                                                  | $2 \times t_{CYC}$ | —   | ns    |
| I2  | Clock low period                                                           | $8 \times t_{CYC}$ | —   | ns    |
| I3  | SCL/SDA rise time ( $V_{IL} = 0.5 \text{ V}$ to $V_{IH} = 2.4 \text{ V}$ ) | —                  | 1   | ms    |
| I4  | Data hold time                                                             | 0                  | —   | ns    |
| I5  | SCL/SDA fall time ( $V_{IH} = 2.4 \text{ V}$ to $V_{IL} = 0.5 \text{ V}$ ) | —                  | 1   | ms    |
| I6  | Clock high time                                                            | $4 \times t_{CYC}$ | —   | ns    |
| I7  | Data setup time                                                            | 0                  | —   | ns    |
| I8  | Start condition setup time (for repeated start condition only)             | $2 \times t_{CYC}$ | —   | ns    |
| I9  | Stop condition setup time                                                  | $2 \times t_{CYC}$ | —   | ns    |

Table 29 lists specifications for the I<sup>2</sup>C output timing parameters shown in Figure 8.

**Table 29. I<sup>2</sup>C Output Timing Specifications between I2C\_SCL and I2C\_SDA**

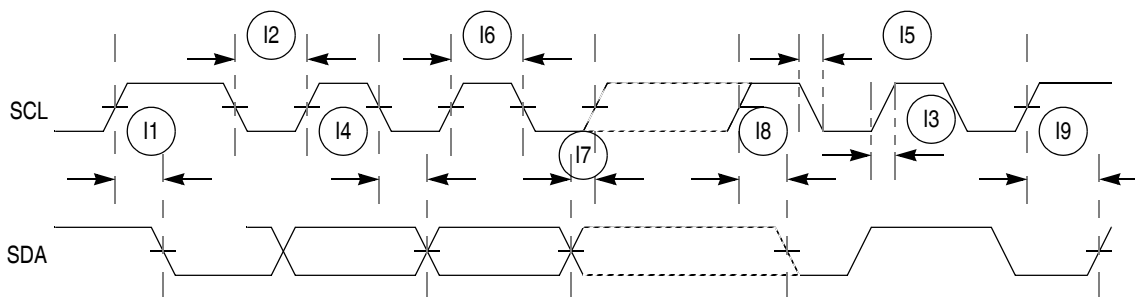
| Num             | Characteristic                                                                        | Min                 | Max | Units         |
|-----------------|---------------------------------------------------------------------------------------|---------------------|-----|---------------|
| I1 <sup>1</sup> | Start condition hold time                                                             | $6 \times t_{CYC}$  | —   | ns            |
| I2 <sup>1</sup> | Clock low period                                                                      | $10 \times t_{CYC}$ | —   | ns            |
| I3 <sup>2</sup> | I2C_SCL/I2C_SDA rise time<br>( $V_{IL} = 0.5 \text{ V}$ to $V_{IH} = 2.4 \text{ V}$ ) | —                   | —   | $\mu\text{s}$ |
| I4 <sup>1</sup> | Data hold time                                                                        | $7 \times t_{CYC}$  | —   | ns            |
| I5 <sup>3</sup> | I2C_SCL/I2C_SDA fall time<br>( $V_{IH} = 2.4 \text{ V}$ to $V_{IL} = 0.5 \text{ V}$ ) | —                   | 3   | ns            |
| I6 <sup>1</sup> | Clock high time                                                                       | $10 \times t_{CYC}$ | —   | ns            |
| I7 <sup>1</sup> | Data setup time                                                                       | $2 \times t_{CYC}$  | —   | ns            |
| I8 <sup>1</sup> | Start condition setup time (for repeated start condition only)                        | $20 \times t_{CYC}$ | —   | ns            |
| I9 <sup>1</sup> | Stop condition setup time                                                             | $10 \times t_{CYC}$ | —   | ns            |

<sup>1</sup> Output numbers depend on the value programmed into the IFDR; an IFDR programmed with the maximum frequency (IFDR = 0x20) results in minimum output timings as shown in Table 29. The I<sup>2</sup>C interface is designed to scale the actual data transition time to move it to the middle of the SCL low period. The actual position is affected by the prescale and division values programmed into the IFDR; however, the numbers given in Table 29 are minimum values.

<sup>2</sup> Because SCL and SDA are open-collector-type outputs, which the processor can only actively drive low, the time SCL or SDA take to reach a high level depends on external signal capacitance and pull-up resistor values.

<sup>3</sup> Specified at a nominal 50-pF load.

Figure 8 shows timing for the values in Table 28 and Table 29.


**Figure 8. I<sup>2</sup>C Input/Output Timings**

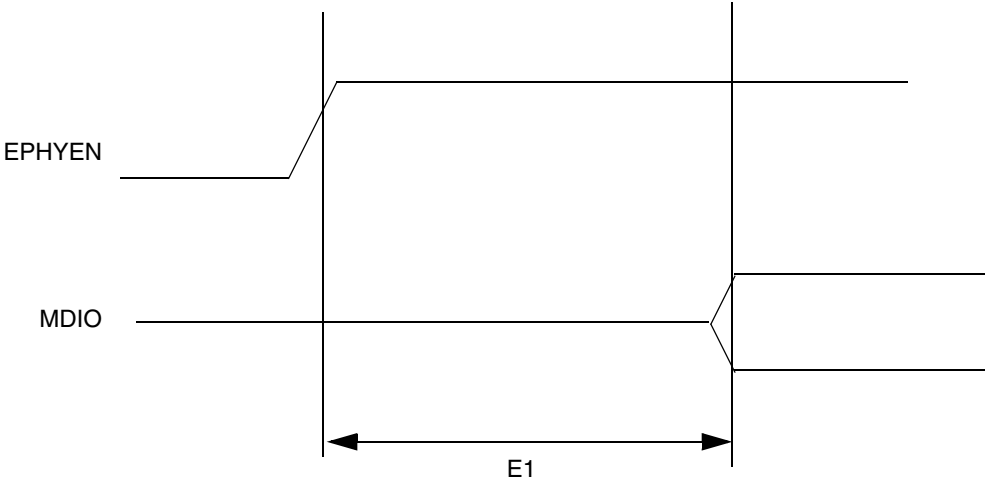
## 2.8 EPHY Parameters

### 2.8.1 EPHY Timing

Table 30 and Figure 9 show the relevant EPHY timing parameters.

**Table 30. EPHY Timing Parameters**

| Num | Characteristic    | Symbol                | Value | Unit          |
|-----|-------------------|-----------------------|-------|---------------|
| E1  | EPHY startup time | $t_{\text{Start-Up}}$ | 360   | $\mu\text{s}$ |



**Figure 9. EPHY Timing**

### 2.8.2 10BASE-T SQE (Heartbeat) Timing

Table 31 and Figure 10 show the relevant 10BASE-T SQE (heartbeat) timing parameters.

**Table 31. 10BASE-T SQE (Heartbeat) Timing Parameters**

| Characteristic                 | Symbol | Min | Typ <sup>1</sup> | Max | Units         |
|--------------------------------|--------|-----|------------------|-----|---------------|
| COL (SQE) delay after TXEN off | t1     | —   | 1.0              | —   | $\mu\text{s}$ |
| COL (SQE) pulse duration       | t2     | —   | 1.0              | —   | $\mu\text{s}$ |

<sup>1</sup> Typical values are at 25°C.

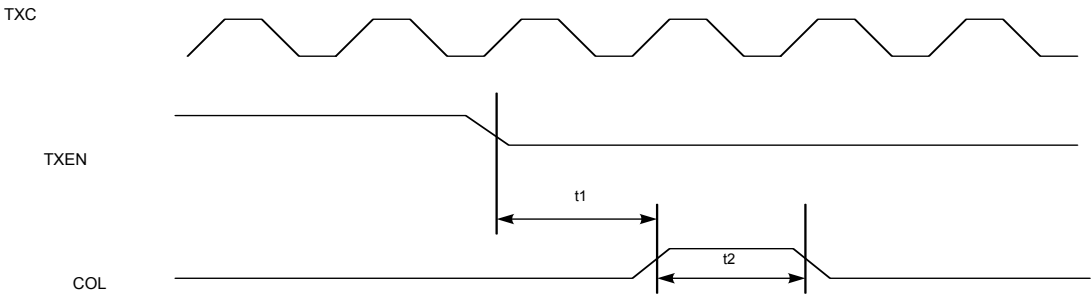


Figure 10. 10BASE-T SQE (Heartbeat) Timing

### 2.8.3 10BASE-T Jab and Unjab Timing

Table 32 and Figure 11 show the relevant 10BASE-T jab and unjab timing parameters.

Table 32. 10BASE-T Jab and Unjab Timing Parameters

| Parameter             | Symbol | Min | Typ <sup>1</sup> | Max | Units |
|-----------------------|--------|-----|------------------|-----|-------|
| Maximum transmit time | t1     | —   | 98               | —   | ms    |
| Unjab time            | t2     | —   | 525              | —   | ms    |

<sup>1</sup> Typical values are at 25°C.

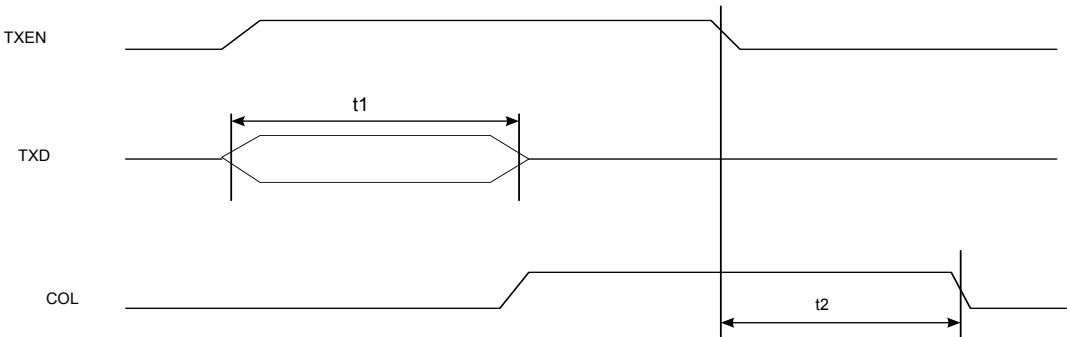


Figure 11. 10BASE-T Jab and Unjab Timing

## 2.8.4 Transceiver Characteristics

**Table 33. 10BASE-T Transceiver Characteristics**

| Parameter                          | Symbol        | Min | Typ | Max | Units      | Test Conditions                                                                 |
|------------------------------------|---------------|-----|-----|-----|------------|---------------------------------------------------------------------------------|
| Peak differential output voltage   | $V_{OP}$      | 2.2 | 2.5 | 2.8 | V          | With specified transformer and line replaced by 100 $\Omega$ ( $\pm 1\%$ ) load |
| Transmit timing jitter             | —             | 0   | 2   | 11  | ns         | Using line model specified in the IEEE 802.3                                    |
| Receive dc input impedance         | $Z_{in}$      | —   | 10  | —   | k $\Omega$ | $0.0 < V_{in} < 3.3$ V                                                          |
| Receive differential squelch level | $V_{squelch}$ | 300 | 400 | 585 | mV         | 3.3 MHz sine wave input                                                         |

**Table 34. 100BASE-TX Transceiver Characteristics**

| Parameter                                 | Symbol    | Min  | Typ  | Max  | Units | Test Conditions                                                                 |
|-------------------------------------------|-----------|------|------|------|-------|---------------------------------------------------------------------------------|
| Transmit Peak Differential Output Voltage | $V_{OP}$  | 0.95 | 1.00 | 1.05 | V     | With specified transformer and line replaced by 100 $\Omega$ ( $\pm 1\%$ ) load |
| Transmit Signal Amplitude Symmetry        | $V_{sym}$ | 98   | 100  | 102  | %     | With specified transformer and line replaced by 100 $\Omega$ ( $\pm 1\%$ ) load |
| Transmit Rise/Fall Time                   | $t_{rf}$  | 3    | 4    | 5    | ns    | With specified transformer and line replaced by 100 $\Omega$ ( $\pm 1\%$ ) load |
| Transmit Rise/Fall Time Symmetry          | $t_{rfs}$ | −0.5 | 0    | +0.5 | ns    | See IEEE 802.3 for details                                                      |
| Transmit Overshoot/UnderShoot             | $V_{osh}$ | —    | 2.5  | 5    | %     |                                                                                 |
| Transmit Jitter                           | —         | 0    | .6   | 1.4  | ns    |                                                                                 |
| Receive Common Mode Voltage               | $V_{cm}$  | —    | 1.6  | —    | V     | $V_{DDRX} = 2.5$ V                                                              |
| Receiver Maximum Input Voltage            | $V_{max}$ | —    | —    | 4.7  | V     | $V_{DDRX} = 2.5$ V. Internal circuits protected by divider in shutdown          |

## 2.9 Analog-to-Digital Converter (ADC) Parameters

Table 35 lists specifications for the analog-to-digital converter.

**Table 35. ADC Parameters<sup>1</sup>**

| Name       | Characteristic                                                      | Min        | Typical         | Max        | Unit             |
|------------|---------------------------------------------------------------------|------------|-----------------|------------|------------------|
| $V_{REFL}$ | Low reference voltage                                               | $V_{SS}$   | —               | $V_{REFH}$ | V                |
| $V_{REFH}$ | High reference voltage                                              | $V_{REFL}$ | —               | $V_{DDA}$  | V                |
| $V_{DDA}$  | Analog supply voltage                                               | 3.0        | 3.3             | 3.6        | V                |
| $V_{ADIN}$ | Input voltages                                                      | $V_{REFL}$ | —               | $V_{REFH}$ | V                |
| RES        | Resolution                                                          | 12         | —               | 12         | bits             |
| INL        | Integral non-linearity (full input signal range) <sup>2</sup>       | —          | $\pm 2.5$       | $\pm 3$    | LSB <sup>3</sup> |
| INL        | Integral non-linearity (10% to 90% input signal range) <sup>4</sup> | —          | $\pm 2.5$       | $\pm 3$    | LSB              |
| DNL        | Differential non-linearity                                          | —          | $-1 < DNL < +1$ | $< +1$     | LSB              |
|            | Monotonicity                                                        | Guaranteed |                 |            |                  |

Table 35. ADC Parameters<sup>1</sup> (continued)

| Name                | Characteristic                                 | Min               | Typical       | Max               | Unit                                 |
|---------------------|------------------------------------------------|-------------------|---------------|-------------------|--------------------------------------|
| $f_{\text{ADIC}}$   | ADC internal clock                             | 0.1               | —             | 5.0               | MHz                                  |
| $R_{\text{AD}}$     | Conversion range                               | $V_{\text{REFL}}$ | —             | $V_{\text{REFH}}$ | V                                    |
| $t_{\text{ADPU}}$   | ADC power-up time <sup>5</sup>                 | —                 | 6             | 13                | $t_{\text{AIC}}$ cycles <sup>6</sup> |
| $t_{\text{REC}}$    | Recovery from auto standby                     | —                 | 0             | 1                 | $t_{\text{AIC}}$ cycles              |
| $t_{\text{ADC}}$    | Conversion time                                | —                 | 6             | —                 | $t_{\text{AIC}}$ cycles              |
| $t_{\text{ADS}}$    | Sample time                                    | —                 | 1             | —                 | $t_{\text{AIC}}$ cycles              |
| $C_{\text{ADI}}$    | Input capacitance                              | —                 | See Figure 12 | —                 | pF                                   |
| $X_{\text{IN}}$     | Input impedance                                | —                 | See Figure 12 | —                 | W                                    |
| $I_{\text{ADI}}$    | Input injection current <sup>7</sup> , per pin | —                 | —             | 3                 | mA                                   |
| $I_{\text{VREFH}}$  | $V_{\text{REFH}}$ current                      | —                 | 0             | —                 | mA                                   |
| $V_{\text{OFFSET}}$ | Offset voltage internal reference              | —                 | $\pm 11$      | $\pm 15$          | mV                                   |
| $E_{\text{GAIN}}$   | Gain error (transfer path)                     | .99               | 1             | 1.01              | —                                    |
| $V_{\text{OFFSET}}$ | Offset voltage external reference              | —                 | $\pm 3$       | —                 | mV                                   |
| SNR                 | Signal-to-noise ratio                          | —                 | 62 to 66      | —                 | dB                                   |
| THD                 | Total harmonic distortion                      | —                 | –75           | —                 | dB                                   |
| SFDR                | Spurious free dynamic range                    | —                 | 75            | —                 | dB                                   |
| SINAD               | Signal-to-noise plus distortion                | —                 | 65            | —                 | dB                                   |
| ENOB                | Effective number OF bits                       | 9.1               | 10.6          | —                 | Bits                                 |

<sup>1</sup> All measurements were made at  $V_{\text{DD}} = 3.3\text{V}$ ,  $V_{\text{REFH}} = 3.3\text{V}$ , and  $V_{\text{REFL}} = \text{ground}$

<sup>2</sup> INL measured from  $V_{\text{IN}} = V_{\text{REFL}}$  to  $V_{\text{IN}} = V_{\text{REFH}}$

<sup>3</sup> LSB = Least Significant Bit

<sup>4</sup> INL measured from  $V_{\text{IN}} = 0.1V_{\text{REFH}}$  to  $V_{\text{IN}} = 0.9V_{\text{REFH}}$

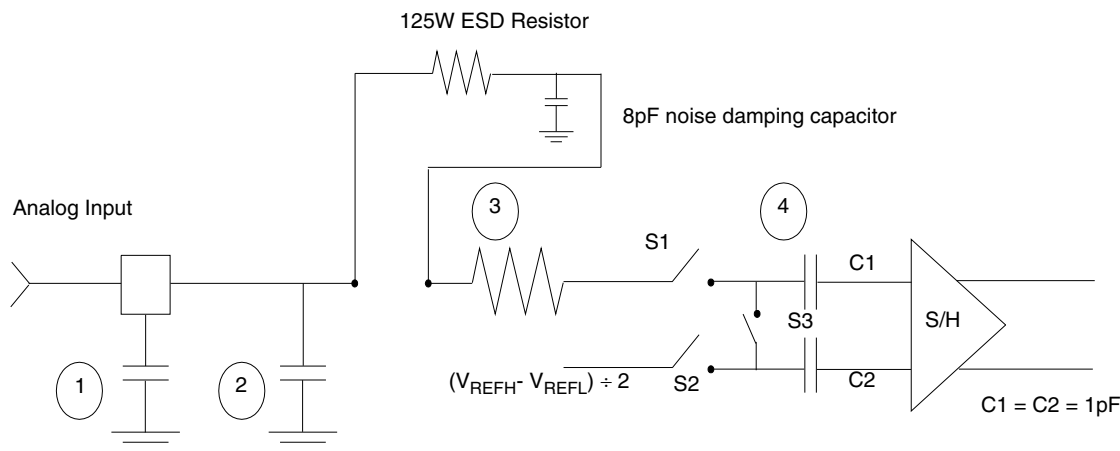
<sup>5</sup> Includes power-up of ADC and  $V_{\text{REF}}$

<sup>6</sup> ADC clock cycles

<sup>7</sup> The current that can be injected or sourced from an unselected ADC signal input without impacting the performance of the ADC

## 2.9.1 Equivalent Circuit for ADC Inputs

Figure 10-17 shows the ADC input circuit during sample and hold. S1 and S2 are always open/closed at the same time that S3 is closed/open. When S1/S2 are closed and S3 is open, one input of the sample and hold circuit moves to  $(V_{\text{REFH}} - V_{\text{REFL}})/2$ , while the other charges to the analog input voltage. When the switches are flipped, the charge on C1 and C2 are averaged via S3, with the result that a single-ended analog input is switched to a differential voltage centered about  $(V_{\text{REFH}} - V_{\text{REFL}})/2$ . The switches switch on every cycle of the ADC clock (open one-half ADC clock, closed one-half ADC clock). There are additional capacitances associated with the analog input pad, routing, etc., but these do not filter into the S/H output voltage, as S1 provides isolation during the charge-sharing phase. One aspect of this circuit is that there is an ongoing input current, which is a function of the analog input voltage,  $V_{\text{REF}}$ , and the ADC clock frequency.



- 1 Parasitic capacitance due to package, pin-to-pin and pin-to-package base coupling; 1.8pF
- 2 Parasitic capacitance due to the chip bond pad, ESD protection devices and signal routing; 2.04pF
- 3 Equivalent resistance for the channel select mux; 100 ohms
- 4 Sampling capacitor at the sample and hold circuit. Capacitor C1 is normally disconnected from the input and is only connected to it at sampling time; 1.4pF
- 5 Equivalent input impedance, when the input is selected =  $\frac{1}{\text{ADC CLOCK RATE} \times (1.4 \times 10^{-12})}$

**Figure 12. Equivalent Circuit for A/D Loading**

## 2.10 DMA Timers Timing Specifications

Table 36 lists timer module AC timings.

**Table 36. Timer Module AC Timing Specifications**

| Name | Characteristic <sup>1</sup>               | Min                | Max | Unit |
|------|-------------------------------------------|--------------------|-----|------|
| T1   | DTIN0 / DTIN1 / DTIN2 / DTIN3 cycle time  | $3 \times t_{CYC}$ | —   | ns   |
| T2   | DTIN0 / DTIN1 / DTIN2 / DTIN3 pulse width | $1 \times t_{CYC}$ | —   | ns   |

<sup>1</sup> All timing references to CLKOUT are given to its rising edge.

## 2.11 EzPort Electrical Specifications

**Table 37. EzPort Electrical Specifications**

| Name | Characteristic                                         | Min                | Max           | Unit |
|------|--------------------------------------------------------|--------------------|---------------|------|
| EP1  | EPCK frequency of operation (all commands except READ) | —                  | $f_{sys} / 2$ | MHz  |
| EP1a | EPCK frequency of operation (READ command)             | —                  | $f_{sys} / 8$ | MHz  |
| EP2  | EPCS_b negation to next EPCS_b assertion               | $2 \times T_{cyc}$ | —             | ns   |
| EP3  | EPCS_B input valid to EPCK high (setup)                | 5                  | —             | ns   |
| EP4  | EPCK high to EPCS_B input invalid (hold)               | 5                  | —             | ns   |
| EP5  | EPD input valid to EPCK high (setup)                   | 2                  | —             | ns   |
| EP6  | EPCK high to EPD input invalid (hold)                  | 5                  | —             | ns   |

**Table 37. EzPort Electrical Specifications (continued)**

| Name | Characteristic                            | Min | Max | Unit |
|------|-------------------------------------------|-----|-----|------|
| EP7  | EPCK low to EPQ output valid (out setup)  | —   | 12  | ns   |
| EP8  | EPCK low to EPQ output invalid (out hold) | 0   | —   | ns   |
| EP9  | EPCS_B negation to EPQ tri-state          | —   | 12  | ns   |

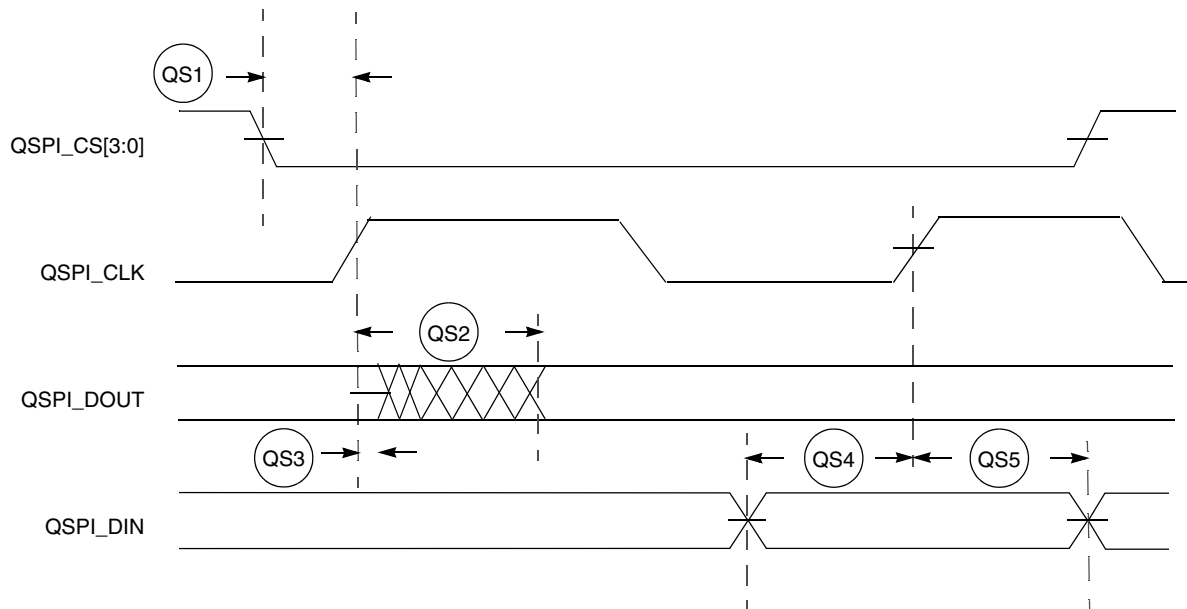
## 2.12 QSPI Electrical Specifications

Table 38 lists QSPI timings.

**Table 38. QSPI Modules AC Timing Specifications**

| Name | Characteristic                                   | Min | Max | Unit      |
|------|--------------------------------------------------|-----|-----|-----------|
| QS1  | QSPI_CS[3:0] to QSPI_CLK                         | 1   | 510 | $t_{CYC}$ |
| QS2  | QSPI_CLK high to QSPI_DOUT valid                 | —   | 10  | ns        |
| QS3  | QSPI_CLK high to QSPI_DOUT invalid (output hold) | 2   | —   | ns        |
| QS4  | QSPI_DIN to QSPI_CLK (input setup)               | 9   | —   | ns        |
| QS5  | QSPI_DIN to QSPI_CLK (input hold)                | 9   | —   | ns        |

The values in Table 38 correspond to Figure 13.


**Figure 13. QSPI Timing**

## 2.13 JTAG and Boundary Scan Timing

Table 39. JTAG and Boundary Scan Timing

| Num | Characteristics <sup>1</sup>                         | Symbol       | Min                | Max | Unit        |
|-----|------------------------------------------------------|--------------|--------------------|-----|-------------|
| J1  | TCLK frequency of operation                          | $f_{JCYC}$   | DC                 | 1/4 | $f_{sys}/2$ |
| J2  | TCLK cycle period                                    | $t_{JCYC}$   | $4 \times t_{CYC}$ | —   | ns          |
| J3  | TCLK clock pulse width                               | $t_{JCW}$    | 26                 | —   | ns          |
| J4  | TCLK rise and fall times                             | $t_{JCRF}$   | 0                  | 3   | ns          |
| J5  | Boundary scan input data setup time to TCLK rise     | $t_{BSDST}$  | 4                  | —   | ns          |
| J6  | Boundary scan input data hold time after TCLK rise   | $t_{BSDHT}$  | 26                 | —   | ns          |
| J7  | TCLK low to boundary scan output data valid          | $t_{BSDV}$   | 0                  | 33  | ns          |
| J8  | TCLK low to boundary scan output high Z              | $t_{BSDZ}$   | 0                  | 33  | ns          |
| J9  | TMS, TDI input data setup time to TCLK rise          | $t_{TAPBST}$ | 4                  | —   | ns          |
| J10 | TMS, TDI input data hold time after TCLK rise        | $t_{TAPBHT}$ | 10                 | —   | ns          |
| J11 | TCLK low to TDO data valid                           | $t_{TDODV}$  | 0                  | 26  | ns          |
| J12 | TCLK low to TDO high Z                               | $t_{TDODZ}$  | 0                  | 8   | ns          |
| J13 | $\overline{TRST}$ assert time                        | $t_{TRSTAT}$ | 100                | —   | ns          |
| J14 | $\overline{TRST}$ setup time (negation) to TCLK high | $t_{TRSTST}$ | 10                 | —   | ns          |

<sup>1</sup> JTAG\_EN is expected to be a static signal. Hence, it is not associated with any timing.

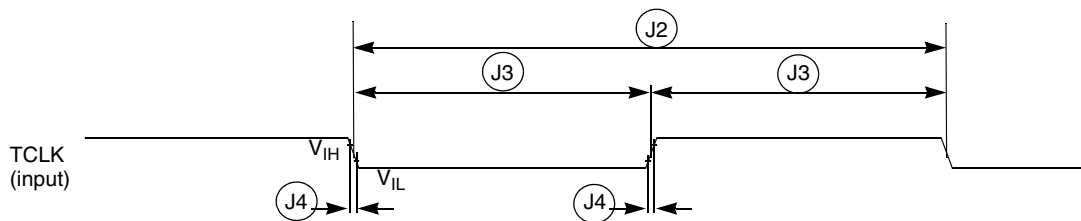


Figure 14. Test Clock Input Timing

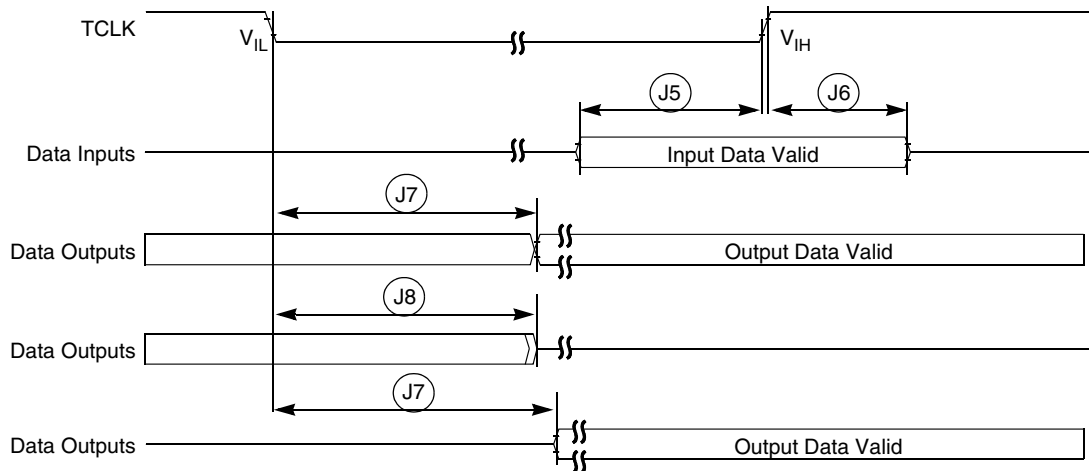


Figure 15. Boundary Scan (JTAG) Timing

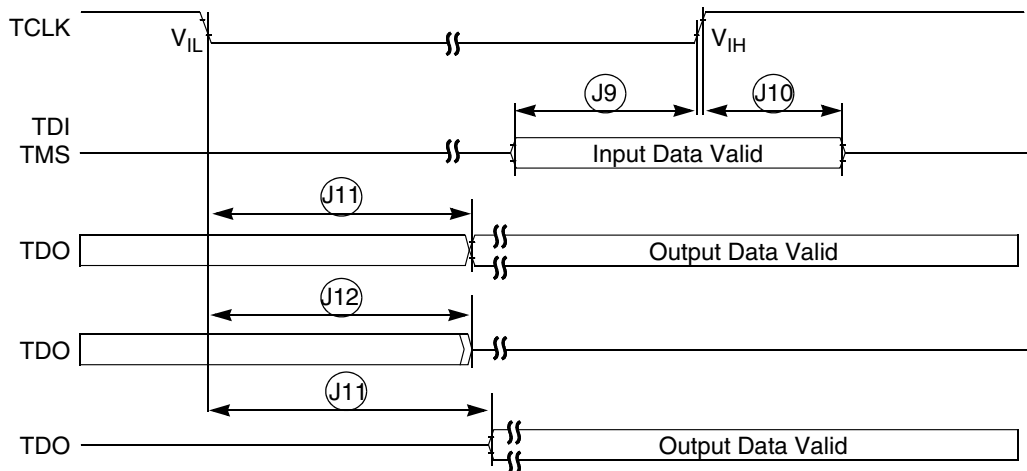


Figure 16. Test Access Port Timing

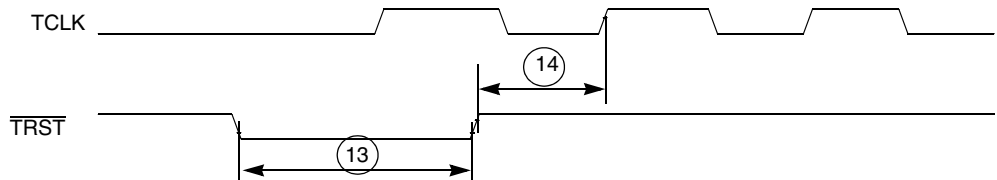


Figure 17. TRST Timing

## 2.14 Debug AC Timing Specifications

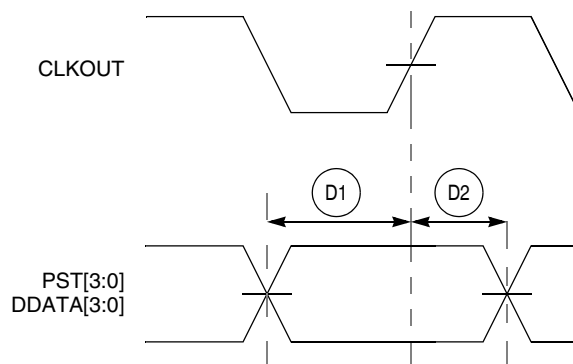
Table 40 lists specifications for the debug AC timing parameters shown in Figure 19.

**Table 40. Debug AC Timing Specification**

| Num             | Characteristic                                         | 60 MHz             |      | Units |
|-----------------|--------------------------------------------------------|--------------------|------|-------|
|                 |                                                        | Min                | Max  |       |
| D1              | PST, DDATA to CLKOUT setup                             | 4                  | —    | ns    |
| D2              | CLKOUT to PST, DDATA hold                              | 1.5                | —    | ns    |
| D3              | DSI-to-DSCLK setup                                     | $1 \times t_{CYC}$ | —    | ns    |
| D4 <sup>1</sup> | DSCLK-to-DSO hold                                      | $4 \times t_{CYC}$ | —    | ns    |
| D5              | DSCLK cycle time                                       | $5 \times t_{CYC}$ | —    | ns    |
| D6              | $\overline{BKPT}$ input data setup time to CLKOUT Rise | 4                  | —    | ns    |
| D7              | $\overline{BKPT}$ input data hold time to CLKOUT Rise  | 1.5                | —    | ns    |
| D8              | CLKOUT high to $\overline{BKPT}$ high Z                | 0.0                | 10.0 | ns    |

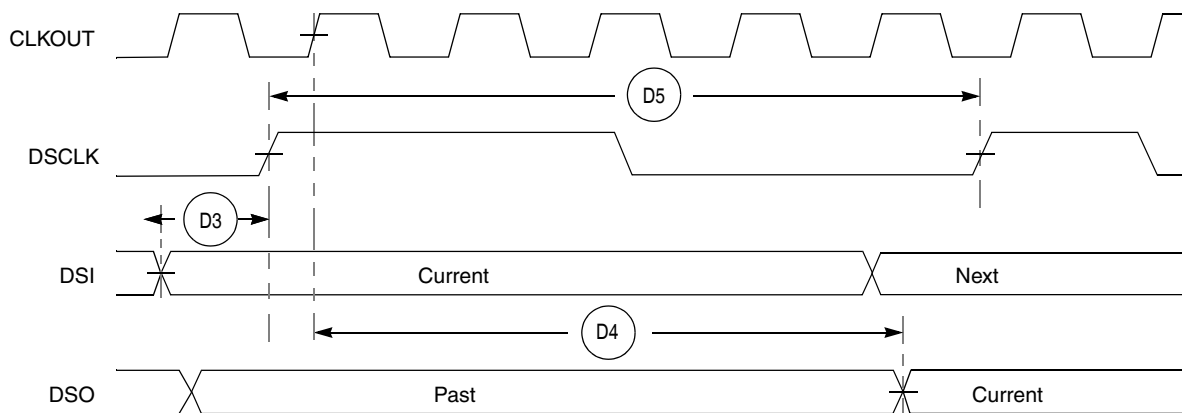
<sup>1</sup> DSCLK and DSI are synchronized internally. D4 is measured from the synchronized DSCLK input relative to the rising edge of CLKOUT.

Figure 18 shows real-time trace timing for the values in Table 40.



**Figure 18. Real-Time Trace AC Timing**

Figure 19 shows BDM serial port AC timing for the values in Table 40.

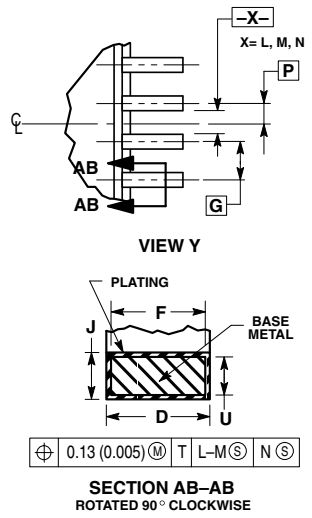
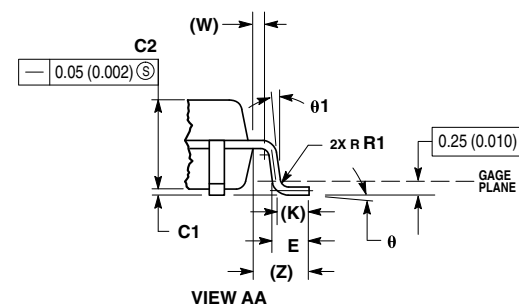
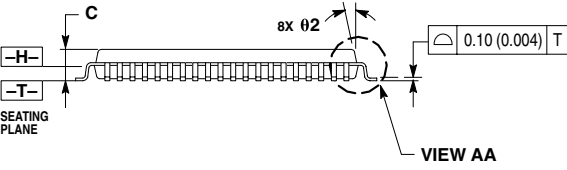
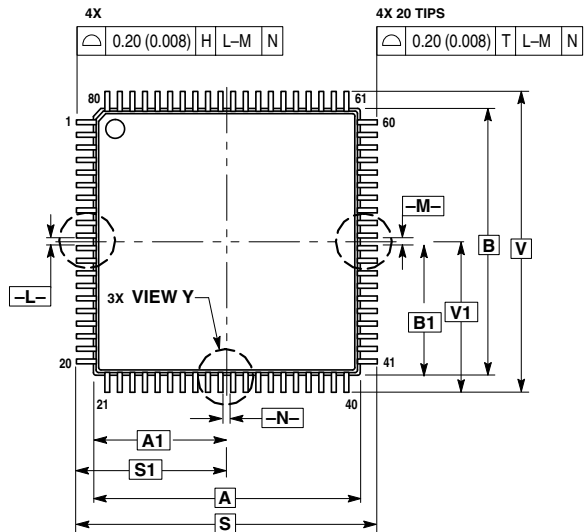


**Figure 19. BDM Serial Port AC Timing**

# 3 Mechanical Outline Drawings

This section describes the physical properties of the MCF52235 and its derivatives.

## 3.1 80-pin LQFP Package



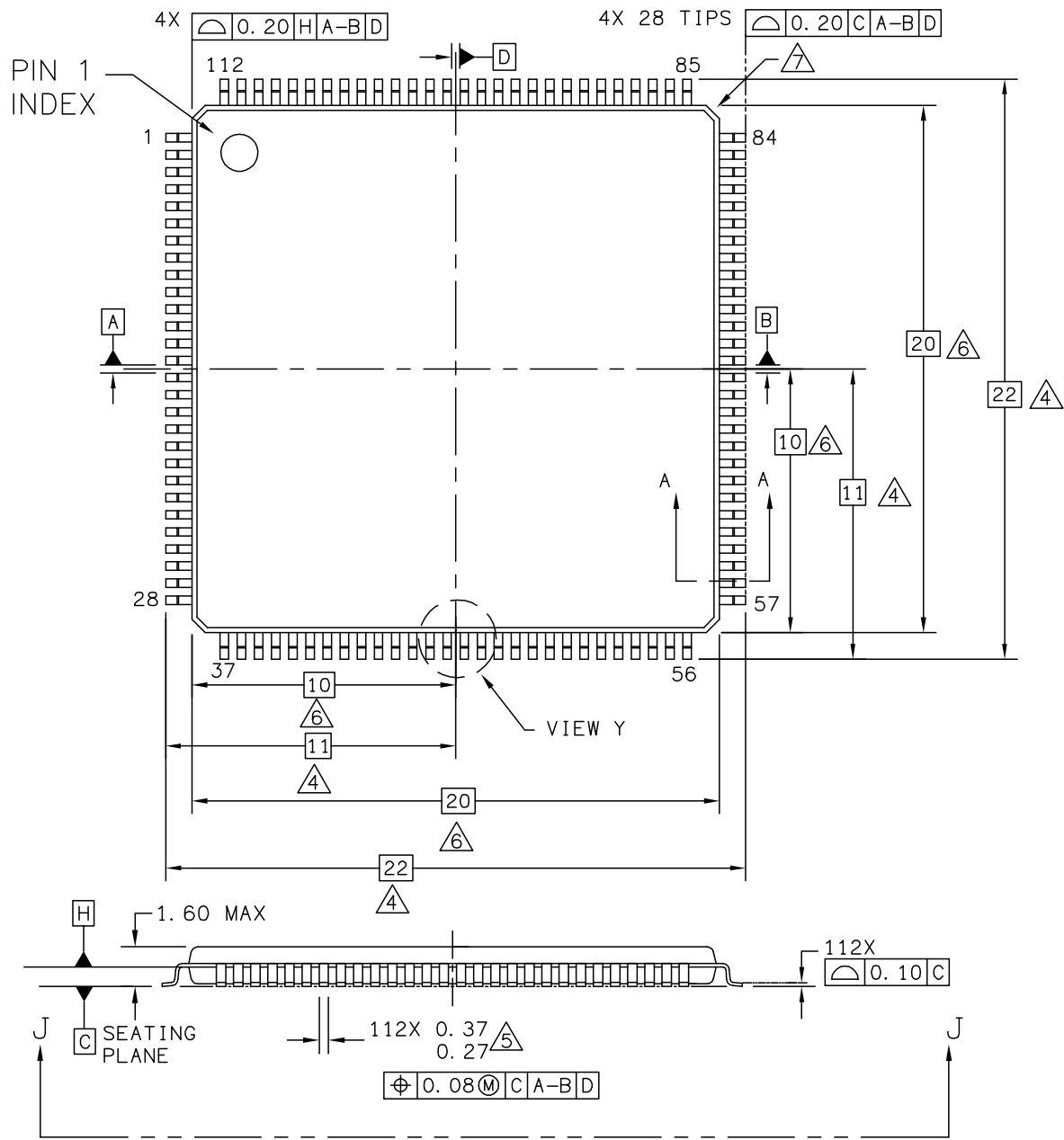
- NOTES:
1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
  2. CONTROLLING DIMENSION: MILLIMETER.
  3. DATUM PLANE -H- IS LOCATED AT BOTTOM OF LEAD AND IS COINCIDENT WITH THE LEAD WHERE THE LEAD EXITS THE PLASTIC BODY AT THE BOTTOM OF THE PARTING LINE.
  4. DATUMS -L-, -M- AND -N- TO BE DETERMINED AT DATUM PLANE -H-.
  5. DIMENSIONS S AND V TO BE DETERMINED AT SEATING PLANE -T-.
  6. DIMENSIONS A AND B DO NOT INCLUDE MOLD PROTRUSION. ALLOWABLE PROTRUSION IS 0.250 (0.010) PER SIDE. DIMENSIONS A AND B DO INCLUDE MOLD MISMATCH AND ARE DETERMINED AT DATUM PLANE -H-.
  7. DIMENSION D DOES NOT INCLUDE DAMBAR PROTRUSION. DAMBAR PROTRUSION SHALL NOT CAUSE THE LEAD WIDTH TO EXCEED 0.460 (0.018). MINIMUM SPACE BETWEEN PROTRUSION AND ADJACENT LEAD OR PROTRUSION 0.07 (0.003).

| DIM | MILLIMETERS |           | INCHES |       |
|-----|-------------|-----------|--------|-------|
|     | MIN         | MAX       | MIN    | MAX   |
| A   | 14.00 BSC   | 0.551 BSC |        |       |
| A1  | 7.00 BSC    | 0.276 BSC |        |       |
| B   | 14.00 BSC   | 0.551 BSC |        |       |
| B1  | 7.00 BSC    | 0.276 BSC |        |       |
| C   | —           | 1.60      | —      | 0.063 |
| C1  | 0.04        | 0.24      | 0.002  | 0.009 |
| C2  | 1.30        | 1.50      | 0.051  | 0.059 |
| D   | 0.22        | 0.38      | 0.009  | 0.015 |
| E   | 0.40        | 0.75      | 0.016  | 0.030 |
| F   | 0.17        | 0.33      | 0.007  | 0.013 |
| G   | 0.65 BSC    | 0.026 BSC |        |       |
| J   | 0.09        | 0.27      | 0.004  | 0.011 |
| K   | 0.50 REF    | 0.020 REF |        |       |
| P   | 0.325 BSC   | 0.013 REF |        |       |
| R1  | 0.10        | 0.20      | 0.004  | 0.008 |
| S   | 16.00 BSC   | 0.630 BSC |        |       |
| S1  | 8.00 BSC    | 0.315 BSC |        |       |
| U   | 0.09        | 0.16      | 0.004  | 0.006 |
| V   | 16.00 BSC   | 0.630 BSC |        |       |
| V1  | 8.00 BSC    | 0.315 BSC |        |       |
| W   | 0.20 REF    | 0.008 REF |        |       |
| Z   | 1.00 REF    | 0.039 REF |        |       |
| 0   | 0°          | 10°       | 0°     | 10°   |
| 01  | 0°          | —         | 0°     | —     |
| 02  | 9°          | 14°       | 9°     | 14°   |

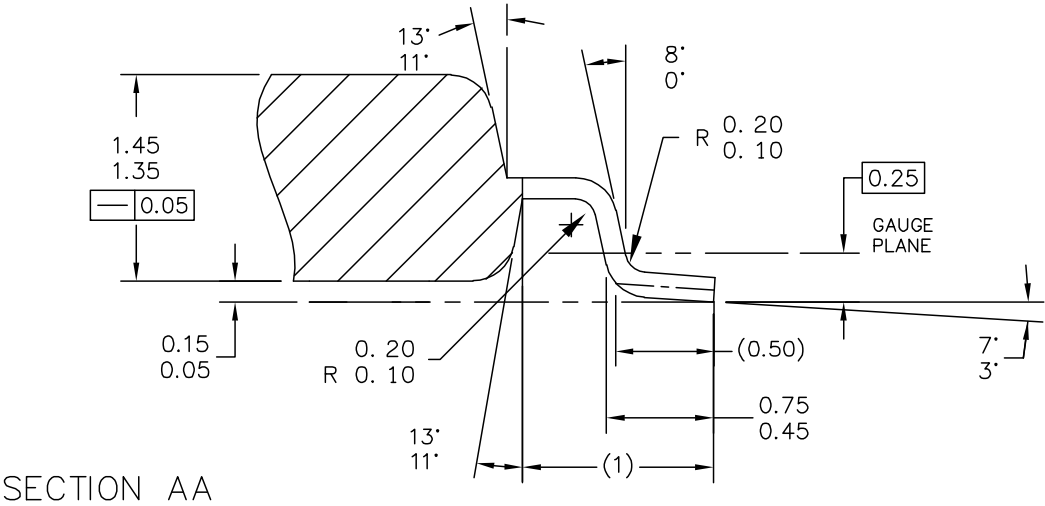
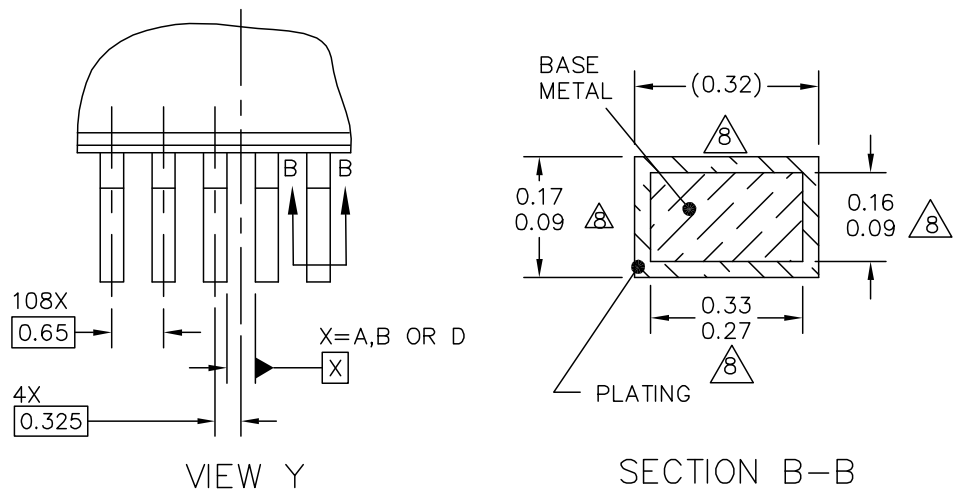
CASE 917A-02  
ISSUE C

DATE 09/21/95

# 3.2 112-pin LQFP Package



|                                                         |  |                            |                            |             |
|---------------------------------------------------------|--|----------------------------|----------------------------|-------------|
| © FREESCALE SEMICONDUCTOR, INC.<br>ALL RIGHTS RESERVED. |  | MECHANICAL OUTLINE         | PRINT VERSION NOT TO SCALE |             |
| TITLE:<br>112LD LQFP<br>20 X 20 X 1.4<br>0.65 PITCH     |  | DOCUMENT NO: 98ASS23330W   |                            | REV: E      |
|                                                         |  | CASE NUMBER: 987-02        |                            | 25 MAY 2005 |
|                                                         |  | STANDARD: JEDEC MS-026 BFA |                            |             |



|                                                         |  |                            |                            |             |
|---------------------------------------------------------|--|----------------------------|----------------------------|-------------|
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| TITLE:<br>112LD LQFP<br>20 X 20 X 1.4<br>0.65 PITCH     |  | DOCUMENT NO: 98ASS23330W   |                            | REV: E      |
|                                                         |  | CASE NUMBER: 987-02        |                            | 25 MAY 2005 |
|                                                         |  | STANDARD: JEDEC MS-026 BFA |                            |             |

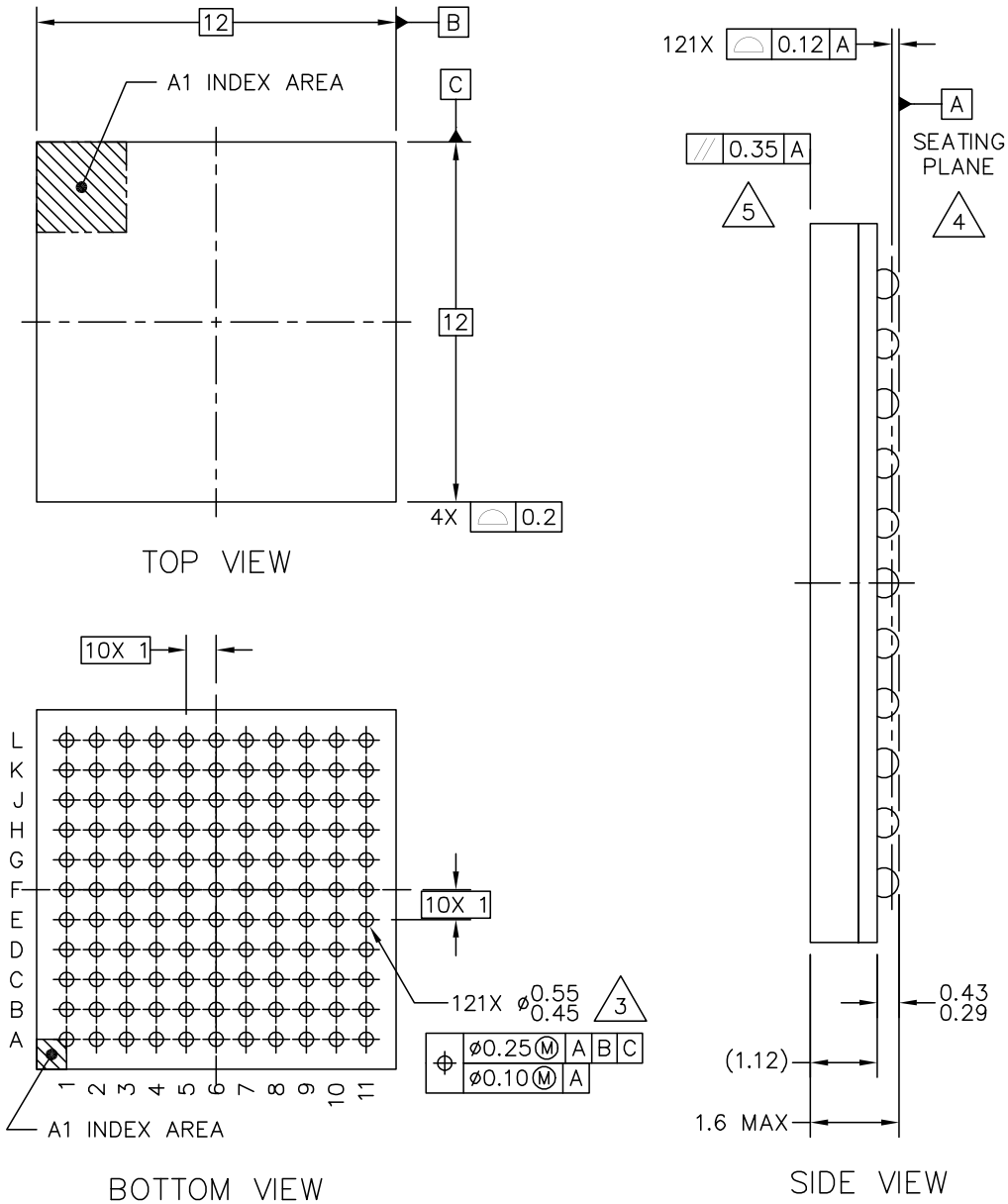
# Mechanical Outline Drawings

## NOTES:

1. DIMENSIONS ARE IN MILLIMETERS.
2. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M-1994.
3. DATUMS A, B AND D TO BE DETERMINED AT DATUM PLANE H.
4. DIMENSIONS TO BE DETERMINED AT SEATING PLANE C.
5. THIS DIMENSION DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL NOT CAUSE THE LEAD WIDTH TO EXCEED THE UPPER LIMIT BY MORE THAN 0.08 MM. DAMBAR CANNOT BE LOCATED ON THE LOWER RADIUS OR THE FOOT. MINIMUM SPACE BETWEEN PROTRUSION AND ADJACENT LEAD OR PROTRUSION 0.07 MM.
6. THIS DIMENSION DOES NOT INCLUDE MOLD PROTRUSION. ALLOWABLE PROTRUSION IS 0.254 MM PER SIDE. THIS DIMENSION IS MAXIMUM PLASTIC BODY SIZE DIMENSIONS INCLUDING MOLD MISMATCH.
7. EXACT SHAPE OF EACH CORNER IS OPTIONAL.
8. THESE DIMENSIONS APPLY TO THE FLAT SECTION OF THE LEAD BETWEEN 0.10 MM AND 0.25 MM FROM THE LEAD TIP.

|                                                           |  |                            |  |                            |  |
|-----------------------------------------------------------|--|----------------------------|--|----------------------------|--|
| © FREESCALE SEMICONDUCTOR, INC.<br>ALL RIGHTS RESERVED.   |  | MECHANICAL OUTLINE         |  | PRINT VERSION NOT TO SCALE |  |
| TITLE:<br>112LD LQFP,<br>20 X 20 X 1.4 PKG,<br>0.65 PITCH |  | DOCUMENT NO: 98ASS23330W   |  | REV: E                     |  |
|                                                           |  | CASE NUMBER: 987-02        |  | 25 MAY 2005                |  |
|                                                           |  | STANDARD: JEDEC MS-026 BFA |  |                            |  |

### 3.3 121 MAPBGA Package



|                                                                        |  |                          |  |                            |  |
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| TITLE: PBGA, LOW PROFILE,<br>121 I/O, 12 X 12 PKG,<br>1 MM PITCH (MAP) |  | DOCUMENT NO: 98ARE10645D |  | REV: 0                     |  |
|                                                                        |  | CASE NUMBER: 1817-01     |  | 15 NOV 2005                |  |
|                                                                        |  | STANDARD: NON-JEDEC      |  |                            |  |

## Mechanical Outline Drawings

NOTES:

1. ALL DIMENSIONS IN MILLIMETERS.
2. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994.
3. MAXIMUM SOLDER BALL DIAMETER MEASURED PARALLEL TO DATUM A.
4. DATUM A, THE SEATING PLANE, IS DETERMINED BY THE SPHERICAL CROWNS OF THE SOLDER BALLS.
5. PARALLELISM MEASUREMENT SHALL EXCLUDE ANY EFFECT OF MARK ON TOP SURFACE OF PACKAGE.

|                                                                        |                          |                    |  |                            |  |
|------------------------------------------------------------------------|--------------------------|--------------------|--|----------------------------|--|
| © FREESCALE SEMICONDUCTOR, INC.<br>ALL RIGHTS RESERVED.                |                          | MECHANICAL OUTLINE |  | PRINT VERSION NOT TO SCALE |  |
| TITLE: PBGA, LOW PROFILE,<br>121 I/O, 12 X 12 PKG,<br>1 MM PITCH (MAP) | DOCUMENT NO: 98ARE10645D |                    |  | REV: 0                     |  |
|                                                                        | CASE NUMBER: 1817-01     |                    |  | 15 NOV 2005                |  |
|                                                                        | STANDARD: NON-JEDEC      |                    |  |                            |  |

# 4 Revision History

**Table 41. Revision History**

| Revision     | Description                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                       |
|--------------|-----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 2 (Jul 2006) | <ul style="list-style-type: none"> <li>Updated available packages.</li> <li>Inserted mechanical drawings.</li> <li>Corrected signal pinouts and table.</li> </ul>                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                 |
| 3 (Feb 2007) | <ul style="list-style-type: none"> <li>Changed signal names TIN to DTIN and TOUT to DTOUT to match the MCF52235 ColdFire® Integrated Microcontroller Reference Manual.</li> <li>Added overbars to extend over entire <math>\overline{UCTSn}</math> and <math>\overline{URTSn}</math> signal name.</li> <li>Added revision history.</li> <li>Formatting, layout, spelling, and grammar corrections.</li> <li>Updated block diagram and feature information to match Revision 3 of the MCF52235 ColdFire® Integrated Microcontroller Reference Manual.</li> <li>Deleted the “PSTCLK cycle time” row from the “Debug AC Timing Specifications” table.</li> <li>Added “EPHY Timing” section.</li> <li>Deleted the “RAM standby supply voltage” entry from Table 19.</li> <li>Changed the minimum value for SNR, THD, SFDR, and SINAD in the “ADC parameters” table (was TBD, is “—”).</li> <li>In the “Pin Functions by Primary and Alternate Purpose” table, changed the pin number for <math>\overline{IRQ11}</math> on the 80 LQFP package (was “—”, is 41).</li> <li>Updated the “Thermal characteristics” table to include proper thermal resistance values.</li> <li>Added two tables, “Active Current Consumption Specifications” and “Current Consumption Specifications in Low-Power Modes”, containing the latest current consumption information.</li> <li>Changed the value of <math>T_j</math> in the “Thermal Characteristics” table (was 105 °C, is 130 °C for all packages).</li> <li>Added the following note to and above the “Thermal Characteristics” table: “The use of this device in one- or two-layer board designs is not recommended due to the limited thermal conductance provided by those boards.”</li> <li>Added the value for <math>\Psi_{jt}</math> for the 121MAPBGA package (2.0 °C/W).</li> </ul> |
| 4 (May 2007) | <ul style="list-style-type: none"> <li>Formatting, layout, spelling, and grammar corrections.</li> <li>Added load test condition information to the “General Purpose I/O Timing” section.</li> <li>Added specifications for <math>V_{LVD}</math> and <math>V_{LVDHYS}</math> to the “DC electrical specifications” table.</li> </ul>                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                              |
| 5 (Sep 2007) | <ul style="list-style-type: none"> <li>Formatting, layout, spelling, and grammar corrections.</li> <li>Added information about the MCF52232 and MCF52236 devices.</li> <li>Revised the part number table to include full Freescale orderable part numbers.</li> <li>Synchronized the “Pin Functions by Primary and Alternate Purpose” table in the device reference manual and data sheet.</li> <li>Added specifications for <math>V_{REFL}</math>, <math>V_{REFH}</math>, and <math>V_{DDA}</math> to the “ADC Parameters” table.</li> <li>Added several EPHY specifications.</li> </ul>                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                         |
| 6 (Oct 2007) | <ul style="list-style-type: none"> <li>Formatting, layout, spelling, and grammar corrections.</li> <li>Changed the data sheet classification (was “Product Preview”, is “Advance Information”).</li> <li>Added the “EzPort Electrical Specifications” section.</li> <li>Updated the “ESD Protection” section.</li> </ul>                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                          |
| 7 (Aug 2008) | <ul style="list-style-type: none"> <li>Changed document type from Advance Information to Technical Data.</li> <li>Added supported device list in subtitle.</li> <li>Removed preliminary text from electrical specifications section as device is fully characterized.</li> <li>Corrected <math>I_{VREFH}</math>, <math>VREFH</math> current unit from “m” to “mA” in ADC specification table.</li> <li>Changed <math>V_{OFFSET}</math> from TBD to — in ADC specification table.</li> </ul>                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                       |
| 8 (Jun 2009) | <ul style="list-style-type: none"> <li>Updated Orderable Part Number Summary table to include MCF52233CAL60A, MCF52235CAL60A, and MCF52236AF50A parts</li> </ul>                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                  |

## Revision History

**Table 41. Revision History (continued)**

| Revision     | Description                                                                                                                                                                                                                           |
|--------------|---------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 8 Sep 2009   | <ul style="list-style-type: none"> <li>Updated Table 25 — PLL Electrical Specifications.</li> </ul>                                                                                                                                   |
| 8 April 2010 | <ul style="list-style-type: none"> <li>Updated Table 37— EzPort Electrical Specifications</li> </ul>                                                                                                                                  |
| 22 Mar 2011  | <ul style="list-style-type: none"> <li>Updated Table Oscillator and PLL Electrical Specification. In EXTAL input high voltage updated VDD to 3.0</li> </ul>                                                                           |
| 23-Mar-2011  | <ul style="list-style-type: none"> <li>Changed EXTAL input high voltage (External reference) Maximum to "3.0V" (Instead of "VDD"). Also, add a note this value has been updated.</li> <li>Updated clock generation feature</li> </ul> |

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